

TLC2202BIP Datasheet

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DiGi Electronics Part Number	TLC2202BIP-DG
Manufacturer	Texas Instruments
Manufacturer Product Number	TLC2202BIP
Description	IC OPAMP GP R-R 1.9MHZ DUAL 8DIP
Detailed Description	CMOS Amplifier 2 Circuit Rail-to-Rail 8-PDIP



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Purchase and inquiry

Manufacturer Product Number:

TLC2202BIP

Series:

-

Amplifier Type:

CMOS

Output Type:

Rail-to-Rail

Gain Bandwidth Product:

1.9 MHz

Voltage - Input Offset:

100 μ V

Current - Output / Channel:

50 mA

Voltage - Supply Span (Max):

16 V

Mounting Type:

Through Hole

Supplier Device Package:

8-PDIP

Manufacturer:

Texas Instruments

Product Status:

Obsolete

Number of Circuits:

2

Slew Rate:

2.7V/ μ s

Current - Input Bias:

1 μ A

Current - Supply:

1.1mA (x2 Channels)

Voltage - Supply Span (Min):

4.6 V

Operating Temperature:

-40°C ~ 85°C

Package / Case:

8-DIP (0.300", 7.62mm)

Base Product Number:

TLC220

Environmental & Export classification

RoHS Status:

RoHS non-compliant

REACH Status:

REACH Unaffected

HTSUS:

8542.33.0001

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

TLC220x, TLC220xA, TLC220xB, TLC220xY

Advanced LinCMOS™ LOW-NOISE PRECISION OPERATIONAL AMPLIFIERS

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- **B Grade Is 100% Tested for Noise**
30 nV/ $\sqrt{\text{Hz}}$ Max at f = 10 Hz
12 nV/ $\sqrt{\text{Hz}}$ Max at f = 1 kHz
- **Low Input Offset Voltage . . . 500 μV Max**
- **Excellent Offset Voltage Stability With Temperature . . . 0.5 $\mu\text{V}/^\circ\text{C}$ Typ**
- **Rail-to-Rail Output Swing**
- **Low Input Bias Current**
1 pA Typ at $T_A = 25^\circ\text{C}$
- **Common-Mode Input Voltage Range Includes the Negative Rail**
- **Fully Specified For Both Single-Supply and Split-Supply Operation**

description

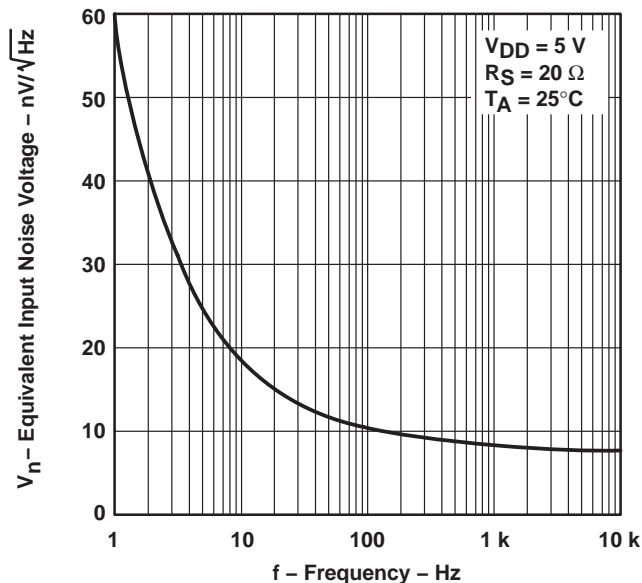
The TLC220x, TLC220xA, TLC220xB, and TLC220xY are precision, low-noise operational amplifiers using Texas Instruments Advanced LinCMOS™ process. These devices combine the noise performance of the lowest-noise JFET amplifiers with the dc precision available previously only in bipolar amplifiers. The Advanced LinCMOS™ process uses silicon-gate technology to obtain input offset voltage stability with temperature and time that far exceeds that obtainable using metal-gate technology. In addition, this technology makes possible input impedance levels that meet or exceed levels offered by top-gate JFET and expensive dielectric-isolated devices.

The combination of excellent DC and noise performance with a common-mode input voltage range that includes the negative rail makes these devices an ideal choice for high-impedance, low-level signal-conditioning applications in either single-supply or split-supply configurations.

The device inputs and outputs are designed to withstand –100-mA surge currents without sustaining latch-up. In addition, internal ESD-protection circuits prevent functional failures at voltages up to 2000 V as tested under MIL-PRF-38535, Method 3015.2; however, care should be exercised in handling these devices as exposure to ESD may result in degradation of the parametric performance.

The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from –40°C to 85°C. The M-suffix devices are characterized for operation over the full military temperature range of –55°C to 125°C.

TYPICAL EQUIVALENT
INPUT NOISE VOLTAGE
VS
FREQUENCY



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS
INSTRUMENTS**

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On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

Advanced LinCMOS™ LOW-NOISE PRECISION OPERATIONAL AMPLIFIERS

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TLC2201 AVAILABLE OPTIONS

T _A	V _{IO} max AT 25°C	V _n max f = 10 Hz AT 25°C	V _n max f = 1 kHz AT 25°C	PACKAGED DEVICES				CHIP FORM‡ (Y)
				SMALL OUTLINE† (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	
0°C to 70°C	200 μV	35 nV/√Hz	15 nV/√Hz	TLC2201ACD	—	—	TLC2201ACP	TLC2201Y
	200 μV	30 nV/√Hz	12 nV/√Hz	TLC2201BCD			TLC2201BCP	
	500 μV	—	—	TLC2201CD			TLC2201CP	
–40°C to 85°C	200 μV	35 nV/√Hz	15 nV/√Hz	TLC2201AID	—	—	TLC2201AIP	—
	200 μV	30 nV/√Hz	12 nV/√Hz	TLC2201BID			TLC2201BIP	
	500 μV	—	—	TLC2201ID			TLC2201IP	
–55°C to 125°C	200 μV	35 nV/√Hz	15 nV/√Hz	TLC2201AMD	TLC2201AMFK	TLC2201AMJG	TLC2201AMP	—
	200 μV	30 nV/√Hz	12 nV/√Hz	TLC2201BMD	TLC2201BMFK	TLC2201BMJG	TLC2201BMP	
	500 μV	—	—	TLC2201MD	TLC2201MFK	TLC2201MJG	TLC2201MP	

† The D packages are available taped and reeled. Add R suffix to device type (e.g. TLC220xBCDR).

‡ Chip forms are tested at 25°C only.

TLC2202 AVAILABLE OPTIONS

T _A	V _{IO} max AT 25°C	V _n max f = 10 Hz AT 25°C	V _n max f = 1 kHz AT 25°C	PACKAGED DEVICES					CHIP FORM‡ (Y)
				SMALL OUTLINE† (D)	PLASTIC SMALL OUTLINE (PS)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	
0°C to 70°C	500 μV	30 nV/√Hz	12 nV/√Hz	TLC2202BCD	—	—	—	TLC2202BCP	TLC2202Y
	500 μV	35 nV/√Hz	15 nV/√Hz	TLC2202ACD	—	—	—	TLC2202ACP	
	1 mV	—	—	TLC2202CD	TLC2202CPSR	—	—	TLC2202CP	
–40°C to 85°C	500 μV	30 nV/√Hz	12 nV/√Hz	TLC2202BID	—	—	—	TLC2202BIP	—
	500 μV	35 nV/√Hz	15 nV/√Hz	TLC2202AID	—	—	—	TLC2202AIP	
	1 mV	—	—	TLC2202ID	—	—	—	TLC2202IP	
–55°C to 125°C	500 μV	30 nV/√Hz	12 nV/√Hz	TLC2202BMD	—	TLC2202BMFK	TLC2202BMJG	TLC2202BMP	—
	500 μV	35 nV/√Hz	15 nV/√Hz	TLC2202AMD	—	TLC2202AMFK	TLC2202AMJG	TLC2202AMP	
	1 mV	—	—	TLC2202MD	—	TLC2202MFK	TLC2202MJG	TLC2202MP	

† The D packages are available taped and reeled. Add R suffix to device type (e.g. TLC220xBCDR).

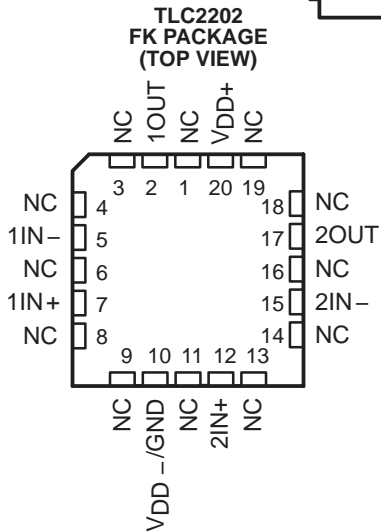
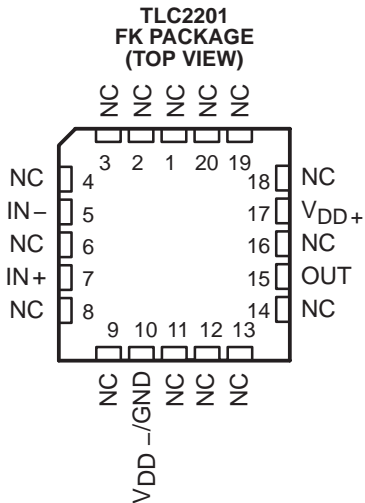
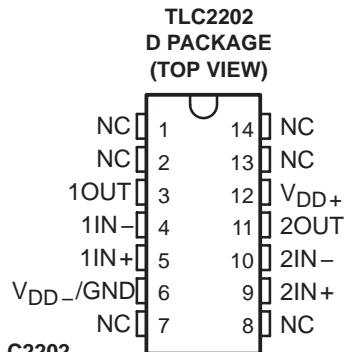
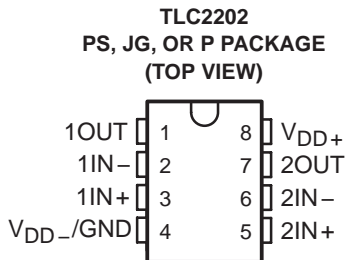
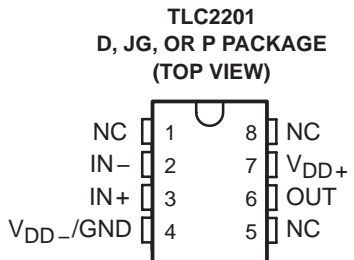
‡ Chip forms are tested at 25°C only.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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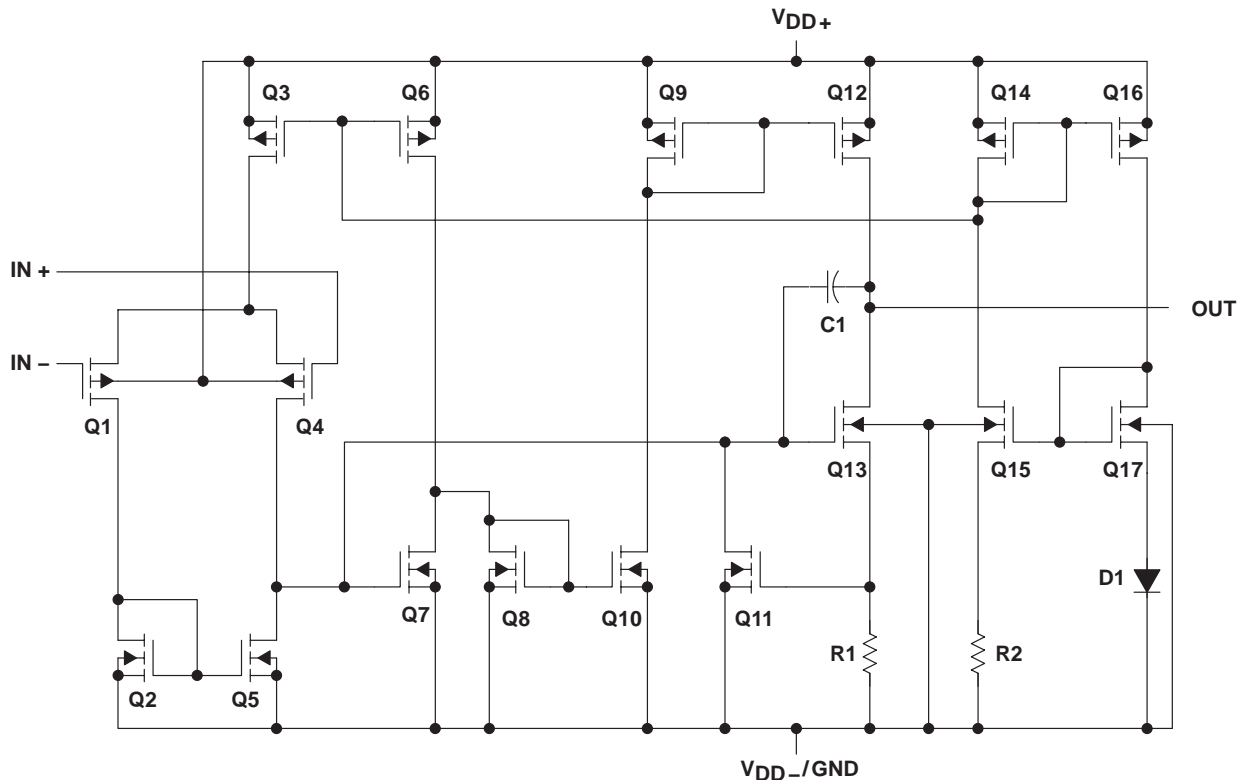
NC – No internal connection

TLC220x, TLC220xA, TLC220xB, TLC220xY

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equivalent schematic (each amplifier)



ACTUAL DEVICE COMPONENT COUNT		
COMPONENT	TLC2201	TLC2202
Transistors	17	34
Resistors	2	2
Diodes	1	4
Capacitors	1	2

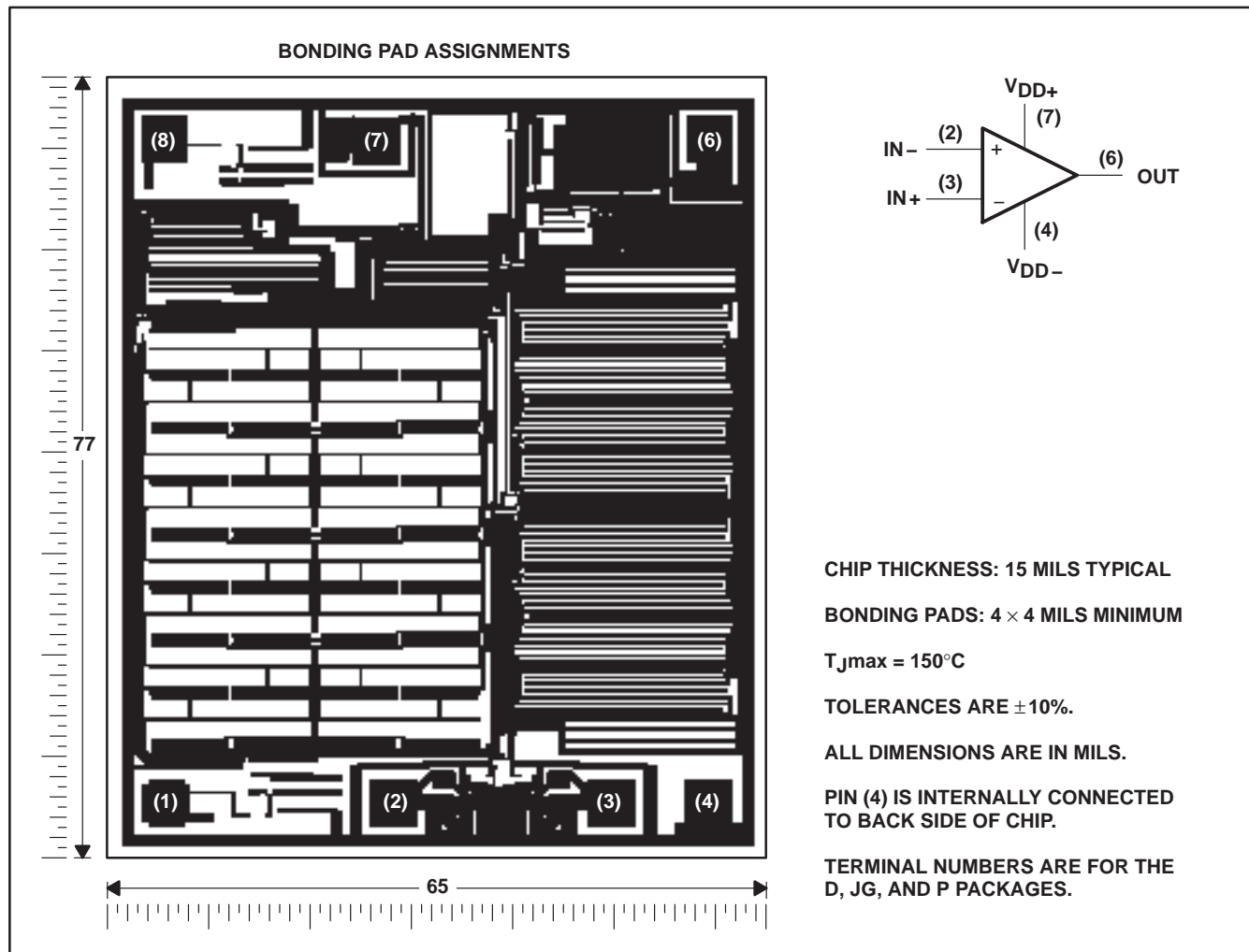
TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC2201C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding path. Chips may be mounted with conductive epoxy or a gold-silicon preform.

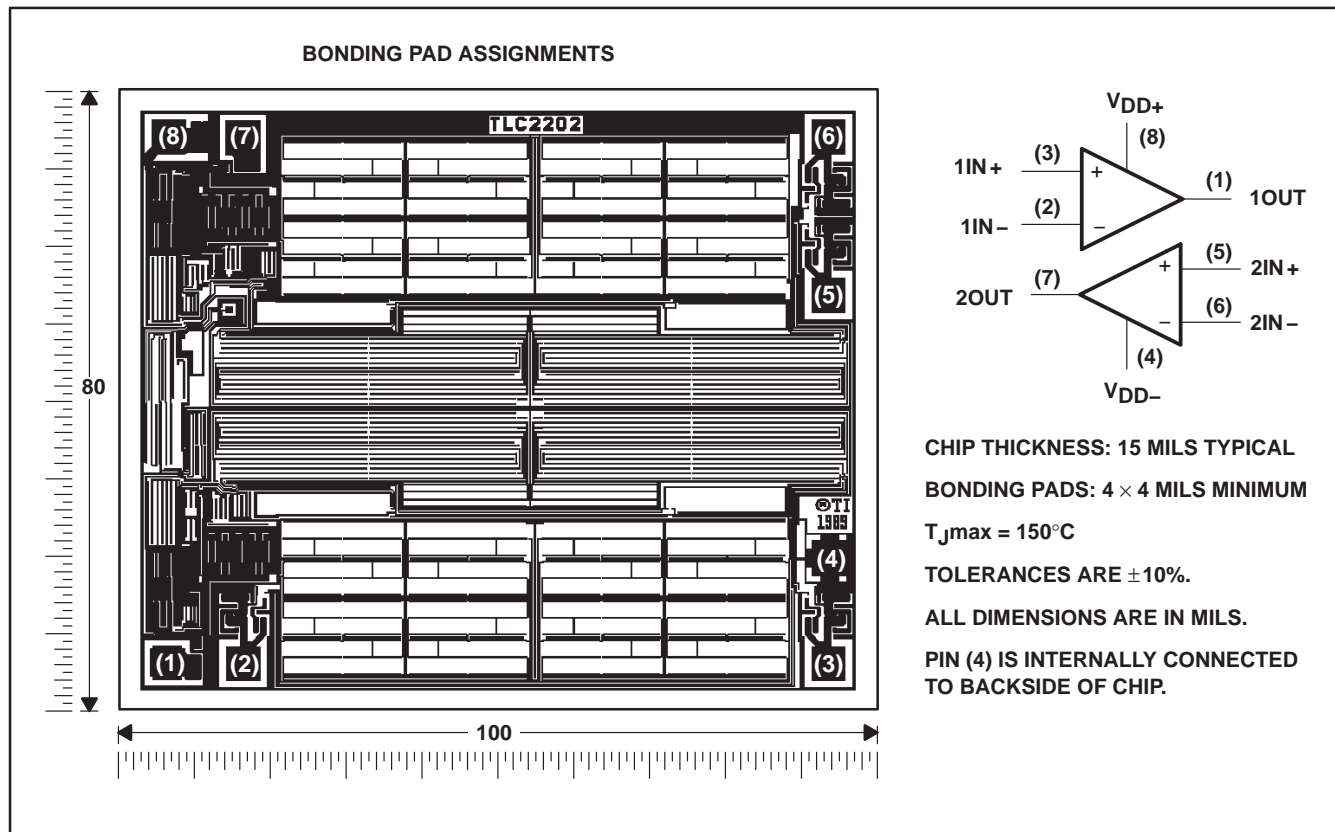


TLC220x, TLC220xA, TLC220xB, TLC220xY Advanced LinCMOS™ LOW-NOISE PRECISION OPERATIONAL AMPLIFIERS

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TLC2202Y chip formation

This chip, when properly assembled, displays characteristics similar to the TLC2202C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{DD+} (see Note 1)	8 V
Supply voltage, V_{DD-}	-8 V
Differential input voltage, V_{ID} (see Note 2)	± 16 V
Input voltage, V_I (any input)	± 8 V
Input current, I_I (each input)	± 5 mA
Output current, I_O (each output)	± 50 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A : C suffix	0°C to 70°C
I suffix	-40°C to 85°C
M suffix	-55°C to 125°C
Storage temperature range	-65°C to 150°C
Case temperature for 60 seconds: FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, PS, or P package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package	300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
- All voltage values except differential voltages are with respect to the midpoint between V_{DD+} and V_{DD-} .
 - Differential voltages are at $IN+$ with respect to $IN-$.
 - The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR	$T_A = 70^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING	ABOVE $T_A = 25^\circ\text{C}$	POWER RATING	POWER RATING	POWER RATING
D-8	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
D-14	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW
PS	770 mW	6.2 mW/°C	496 mW	403 mW	155 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

	C SUFFIX		I SUFFIX		M SUFFIX		UNIT
	MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, $V_{DD\pm}$	± 2.3	± 8	± 2.3	± 8	± 2.3	± 8	V
Common-mode input voltage, V_{IC}	V_{DD-}	$V_{DD+} - 2.3$	V_{DD-}	$V_{DD+} - 2.3$	V_{DD-}	$V_{DD+} - 2.3$	V
Operating free-air temperature, T_A	0	70	-40	85	-55	125	°C

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TLC2201C electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201C			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	500	μV	
		Full range	600			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60	pA	
		Full range	100			
I_{IB} Input bias current		25°C	1	60	pA	
		Full range	100			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	–5 to 2.7		V	
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	–4.7	–4.9	V	
		Full range	–4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	400	560	V/mV	
		Full range	300			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	90	100		
		Full range	70			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	Full range	85		dB	
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V to } \pm 8\ \text{V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.1	1.5	mA	
		Full range	1.5			

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201C operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201C			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	2	2.7	$\text{V}/\mu\text{s}$	
		Full range	1.5			
V_n Equivalent input noise voltage	f = 10 Hz	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	f = 1 kHz	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C	0.5		μV	
	f = 0.1 to 10 Hz	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	f = 10 kHz, $R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	48°			

† Full range is 0°C to +70°C.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201C electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AC			TLC2201BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	200		80	200	μV	
		Full range			300		300		
α_{VIO} Temperature coefficient of input offset voltage		Full range		0.5			0.5	$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C		0.5	60		0.5	60	pA
		Full range			100			100	
I_{IB} Input bias current		25°C		1	60		1	60	pA
		Full range			100			100	
V_{ICR} Common-mode input voltage range		$R_S = 50\ \Omega$	Full range	-5 to 2.7			-5 to 2.7		V
V_{OM+} Maximum positive peak output voltage swing		$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V
	Full range			4.7			4.7		
V_{OM-} Maximum negative peak output voltage swing	25°C		-4.7	-4.9		-4.7	-4.9	V	
	Full range			-4.7			-4.7		
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	400	560		400	560	V/mV	
		Full range		300			300		
	$V_O = \pm 4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	90	100		90	100		
		Full range		70			70		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	25°C	90	115		90	115	dB	
		Full range		85			85		
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\text{ V to } \pm 8\text{ V}$	25°C	90	110		90	110	dB	
		Full range		85			85		
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C		1.1	1.5		1.1	1.5	mA
		Full range			1.5			1.5	

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201C operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AC			TLC2201BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	2	2.7		2	2.7		V/ μ s
		Full range	1.5			1.5			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$
	$f = 1\text{ kHz}$	25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$	25°C		0.5			0.5		μ V
	$f = 0.1\text{ to }10\text{ Hz}$	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6	fA/ $\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		1.9			1.9	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		48°			48°		

† Full range is 0°C to +70°C.

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201C electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201C			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, \quad R_S = 50\ \Omega$	25°C		100	500	μV
		Full range			600	
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range		0.5		$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C		0.001	0.005	$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		25°C		0.5	60	pA
		Full range			100	
I_{IB} Input bias current		25°C		1	60	pA
		Full range			100	
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		V	
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0 50	mV	
		Full range		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, \quad R_L = 500\ \text{k}\Omega$	25°C	150	315	V/mV	
		Full range	100			
	$V_O = 1\text{ V to }4\text{ V}, \quad R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	15			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, \quad V_O = 0, \quad R_S = 50\ \Omega$	25°C	90	110	dB	
		Full range	85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \quad \text{No load}$	25°C		1 1.5	mA	
		Full range		1.5		

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201C operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201C			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}, \quad R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C	1.8	2.5	$\text{V}/\mu\text{s}$	
		Full range	1.3			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C		18	$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5	μV	
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7		
I_n Equivalent input noise current		25°C		0.6	$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, \quad R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C		1.8	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C		45°		

† Full range is 0°C to +70°C.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201C electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AC			TLC2201BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	200		80	200	μV	
		Full range		300		300			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range		100		100			
I_{IB} Input bias current		25°C	1	60		1	60	pA	
		Full range		100		100			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7			0 to 2.7	V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	mV	
		Full range			50		50		
AVD Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	100			100			
		25°C	25	55		25	55		
		Full range	15			15			
$CMRR$ Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	90	110		90	110	dB	
		Full range	85			85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD} \pm / \Delta V_{IO}$)	$V_{DD} = 4.6\ \text{V to } 16\ \text{V}$	25°C	90	110		90	110	dB	
		Full range	85			85			
I_{DD} Supply current	$V_O = 2.5\ \text{V}, \text{ No load}$	25°C		1	1.5		1	mA	
		Full range			1.5		1.5		

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201C operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AC			TLC2201BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V},$ $R_L = 10\text{ k}\Omega, C_L = 100\text{ pF}$	25°C	1.8	2.5		1.8	2.5		V/ μ s
		Full range	1.3			1.3			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$	25°C		18	35		18	30	$nV/\sqrt{\text{Hz}}$
	$f = 1\text{ kHz}$	25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$	25°C		0.5			0.5		μ V
	$f = 0.1\text{ to }10\text{ Hz}$	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6		$fA/\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\text{ kHz}, R_L = 10\text{ k}\Omega,$ $C_L = 100\text{ pF}$	25°C		1.8			1.8		MHz
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega, C_L = 100\text{ pF}$	25°C		45°			45°		

† Full range is 0°C to +70°C.

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202C electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise specified)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202C			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	1000	μV	
		Full range	1150			
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
		25°C	0.5		pA	
I_{IO} Input offset current		Full range	100			
		25°C	1			
I_{IB} Input bias current		Full range	100			
	V_{ICR} Common-mode input voltage range	Full range	-5 to 2.7		V	
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	-4.7	-4.9	V	
		Full range	-4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	300	560	V/mV	
		Full range	200			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	50	100		
		Full range	25			
CMRR Common-mode rejection ratio	$V_O = 0, R_S = 50\ \Omega, V_{IC} = V_{ICRmin}$	25°C	80	115	dB	
		Full range	80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V}$ to $\pm 8\ \text{V}$	25°C	80	110	dB	
		Full range	80			
I_{DD} Supply current	$V_O = 0, \text{No load}$	25°C	1.8	2.7	mA	
		Full range	2.7			

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202C operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202C			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.8	2.7	$\text{V}/\mu\text{s}$	
		Full range	1.3			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1$ to $1\ \text{Hz}$	25°C	0.5		μV	
	$f = 0.1$ to $10\ \text{Hz}$	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	48°			

† Full range is 0°C to +70°C.



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TLC2202C electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AC			TLC2202BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	500		80	500	μV	
		Full range			650		650		
α_{VIO} Temperature coefficient of input offset voltage		Full range		0.5			0.5	$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range			100		100		
I_{IB} Input bias current		25°C	1	60		1	60	pA	
		Full range			100		100		
V_{ICR} Common-mode input voltage range		$R_S = 50\ \Omega$	Full range	-5 to 2.7			-5 to 2.7	V	
V_{OM+} Maximum positive peak output voltage swing		$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V
	Full range				4.7		4.7		
V_{OM-} Maximum negative peak output voltage swing	25°C		-4.7	-4.9		-4.7	-4.9	V	
	Full range				-4.7		-4.7		
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	300	560		300	560	V/mV	
		Full range			200		200		
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	50	100		50	100		
		Full range			25		25		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	80	115		80	115	dB	
		Full range			80		80		
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V}$ to $\pm 8\ \text{V}$	25°C	80	110		80	110	dB	
		Full range			80		80		
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C		1.8	2.7		1.8	2.7	mA
		Full range			2.7		2.7		

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202C operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AC			TLC2202BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.8	2.7		1.8	2.7	$\text{V}/\mu\text{s}$	
		Full range			1.3		1.3		
V_n Equivalent input noise voltage (see Note 5)	$f = 10\ \text{Hz}$	25°C		18	35		18	30	$\text{nV}/\sqrt{\text{Hz}}$
	$f = 1\ \text{kHz}$	25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1$ to $1\ \text{Hz}$	25°C		0.5			0.5		μV
	$f = 0.1$ to $10\ \text{Hz}$	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6	$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.9			1.9	MHz	
ϕ_m Phase margin at unity gain	$R_I = 10\ \text{k}\Omega, C_I = 100\ \text{pF}$	25°C		48°			48°		

† Full range is 0°C to +70°C.

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202C electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202C			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	1000		μV
		Full range		1150		
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5			$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		$\mu\text{V}/\text{mo}$
		25°C	0.5	60		pA
I_{IO} Input offset current		Full range		100		
I_{IB} Input bias current	25°C	1	60		pA	
	Full range		100			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		V	
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		V
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C	0	50		mV
		Full range		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		V/mV
		Full range	100			
	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	15			
CMRR Common-mode rejection ratio	$V_O = 0, R_S = 50\ \Omega, V_{IC} = V_{ICRmin}$	25°C	75	110		dB
		Full range	75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\ \text{V to } 16\ \text{V}$	25°C	80	110		dB
		Full range	80			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.7	2.6		mA
		Full range		2.6		

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202C operating characteristics at specified free-air temperature, $V_{DD} = 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202C			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\ \text{V to } 2.5\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.6	2.5		$\text{V}/\mu\text{s}$
		Full range	1.1			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C		18		$\text{nV}/\sqrt{\text{Hz}}$
	$f = 1\ \text{kHz}$	25°C		8		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{to } 1\ \text{Hz}$	25°C		0.5		μV
	$f = 0.1\ \text{to } 10\ \text{Hz}$	25°C		0.7		
I_n Equivalent input noise current		25°C		0.6		$\text{fA}/\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.9		MHz
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		47°		

† Full range is 0°C to +70°C.



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TLC2202C electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AC			TLC2202BC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage		25°C	80	500		80	500	μV	
		Full range			650		650		
α_{VIO} Temperature coefficient of input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	Full range	0.5			0.5			$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
		Full range	0.5			0.5			
I_{IO} Input offset current		25°C		1	60		1	60	pA
		Full range	100			100			
I_{IB} Input bias current		25°C		1	60		1	60	pA
	Full range	100			100				
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		0 to 2.7		V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	50	mV
		Full range	50			50			
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	100			100			
	$V_O = 1\text{ V to }4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		25	55		
		Full range	15			15			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	75	110		75	110	dB	
		Full range	75			75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	80	110		80	110	dB	
		Full range	80			80			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \text{ No load}$	25°C		1.7	2.6		1.7	2.6	mA
		Full range	2.6			2.6			

† Full range is 0°C to +70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202C operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AC			TLC2202BC			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.6	2.5		1.6	2.5	V/ μs		
		Full range	1.1			1.1				
V_n Equivalent input noise voltage (see Note 5)	$f = 10\ \text{Hz}$	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8	15		8	12		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5			0.5			μV
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7			0.7			
I_n Equivalent input noise current		25°C		0.6			0.6			fA/ $\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.9			1.9			MHz
ϕ_m Phase margin at unity gain	$R_I = 10\ \text{k}\Omega, C_I = 100\ \text{pF}$	25°C		47°			47°			

† Full range is 0°C to +70°C.

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.



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TLC2201I electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201I			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, \quad R_S = 50\ \Omega$	25°C	100	500	μV	
		Full range	650			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
		25°C	0.5		pA	
I_{IO} Input offset current		Full range	150			
		I_{IB} Input bias current	25°C	1		pA
Full range			150			
V_{ICR} Common-mode input voltage range		$R_S = 50\ \Omega$	Full range	–5 to 2.7		V
V_{OM+} Maximum positive peak output voltage swing		$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V
	Full range		4.7			
V_{OM-} Maximum negative peak output voltage swing	25°C		–4.7	–4.9	V	
	Full range		–4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, \quad R_L = 500\ \text{k}\Omega$	25°C	400	560	V/mV	
		Full range	250			
	$V_O = \pm 4\ \text{V}, \quad R_L = 10\ \text{k}\Omega$	25°C	90	100		
		Full range	65			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin},$ $V_O = 0, \quad R_S = 50\ \Omega$	25°C	90	115	dB	
		Full range	85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V to } \pm 8\ \text{V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 0, \quad \text{No load}$	25°C	1.1	1.5	mA	
		Full range	1.5			

† Full range is -40°C to $+85^\circ\text{C}$.NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201I operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201I			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, \quad R_L = 10\ \text{k}\Omega,$ $C_L = 100\ \text{pF}$	25°C	2	2.7	$\text{V}/\mu\text{s}$	
		Full range	1.4			
V_n Equivalent input noise voltage	f = 10 Hz	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	f = 1 kHz	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C	0.5		μV	
	f = 0.1 to 10 Hz	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	f = 10 kHz, $R_L = 10\ \text{k}\Omega,$ $C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C	48°			

† Full range is -40°C to $+85^\circ\text{C}$.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201I electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AI			TLC2201BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	200		80	200	μV	
		Full range			350		350		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range			150		150		
I_{IB} Input bias current		25°C	1	60		1	60	pA	
		Full range			150		150		
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	–5 to 2.7		–5 to 2.7		V		
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	–4.7	–4.9		–4.7	–4.9	V	
		Full range	–4.7			–4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	400	560		400	560	V/mV	
		Full range	250			250			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	90	100		90	100		
		Full range	65			65			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	25°C	90	115		90	115	dB	
		Full range	85			85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V}$ to $\pm 8\ \text{V}$	25°C	90	110		90	110	dB	
		Full range	85			85			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.1	1.5		1.1	1.5	mA	
		Full range			1.5		1.5		

† Full range is -40°C to $+85^\circ\text{C}$.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation assuming an activation energy of 0.96 eV.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201I operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A^\dagger	TLC2201AI			TLC2201BI			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR	Slew rate at unity gain	$V_O = \pm 2.3\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	2	2.7		2	2.7	V/ μ s	
			Full range	1.4			1.4			
V_n	Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$	25°C	18	35		18	30	nV/ $\sqrt{\text{Hz}}$	
			25°C	8	15		8	12		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$	25°C	0.5			0.5			μ V
			25°C	0.7			0.7			
I_n	Equivalent input noise current		25°C	0.6			0.6			fA/ $\sqrt{\text{Hz}}$
	Gain-bandwidth product	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	1.9			1.9			MHz
ϕ_m	Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	48°			48°			

† Full range is -40°C to $+85^\circ\text{C}$.

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201I electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A^\dagger	TLC2201I			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, \quad R_S = 50\ \Omega$	25°C		100	500	μV
		Full range			650	
α_{VIO} Temperature coefficient of input offset voltage		Full range		0.5		$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C		0.001	0.005	$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		25°C		0.5	60	pA
		Full range			150	
I_{IB} Input bias current		25°C		1	60	pA
		Full range			150	
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		V	
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0 50	mV	
		Full range		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V},$ $R_L = 500\ \text{k}\Omega$	25°C	150	315	V/mV	
		Full range	100			
	$V_O = 1\text{ V to }4\text{ V},$ $R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	15			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}},$ $V_O = 0, \quad R_S = 50\ \Omega$	25°C	90	110	dB	
		Full range	85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \quad \text{No load}$	25°C		1 1.5	mA	
		Full range		1.5		

† Full range is -40°C to $+85^\circ\text{C}$.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201I operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A^\dagger	TLC2201I			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V},$ $R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C	1.8	2.5	$\text{V}/\mu\text{s}$	
		Full range	1.2			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C		18	$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5	μV	
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7		
I_n Equivalent input noise current		25°C		0.6	$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, \quad R_L = 10\ \text{k}\Omega,$ $C_L = 100\ \text{pF}$	25°C		1.8	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, \quad C_L = 100\ \text{pF}$	25°C		45°		

† Full range is -40°C to $+85^\circ\text{C}$.

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TLC2201I electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AI			TLC2201BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	200		80	200	μA	
		Full range		350		350			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range		150		150			
I_{IB} Input bias current	25°C	1	60		1	60	pA		
	Full range		150		150				
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7			0 to 2.7	V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	mV	
		Full range		50		50			
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	100			100			
	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		25	55		
		Full range	15			15			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	90	110		90	110	dB	
		Full range	85			85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD} = 4.6\ \text{V to } 16\ \text{V}$	25°C	90	110		90	110	dB	
		Full range	85			85			
I_{DD} Supply current	$V_O = 2.5\ \text{V}, \text{ No load}$	25°C		1	1.5		1	mA	
		Full range			1.5		1.5		

† Full range is -40°C to $+85^\circ\text{C}$.NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201I operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AI			TLC2201BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	1.8	2.5		1.8	2.5		V/ μ s
		Full range	1.2			1.2			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$
	$f = 1\text{ kHz}$	25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$	25°C		0.5			0.5		μ V
	$f = 0.1\text{ to }10\text{ Hz}$	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6		fA/ $\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		1.8			1.8		MHz
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		45°			45°		

† Full range is -40°C to $+85^\circ\text{C}$.

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202I electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202I			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	1000	μV	
		Full range	1200			
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5	$\mu\text{V}/^\circ\text{C}$		
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60	pA	
		Full range	150			
I_{IB} Input bias current		25°C	1	60	pA	
		Full range	150			
V_{ICR} Common-mode input voltage range		$R_S = 50\ \Omega$	Full range	-5 to 2.7	V	
V_{OM+} Maximum positive peak output voltage swing		$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V
V_{OM-} Maximum negative peak output voltage swing	Full range		4.7			
	25°C		-4.7	-4.9	V	
Full range	-4.7					
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	300	560	V/mV	
		Full range	150			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	50	100		
		Full range	25			
CMRR Common-mode rejection ratio	$V_O = 0, V_{IC} = V_{ICR\text{min}}, R_S = 50\ \Omega$	25°C	80	115	dB	
		Full range	80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = \pm 2.3\ \text{V}$ to $\pm 8\ \text{V}$	25°C	80	110	dB	
		Full range	80			
I_{DD} Supply current	$V_O = 0, \text{No load}$	25°C	1.8	2.7	mA	
		Full range	2.7			

† Full range is -40°C to $+85^\circ\text{C}$.NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202I operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202I			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.8	2.7	$\text{V}/\mu\text{s}$	
		Full range	1.2			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1$ to $1\ \text{Hz}$	25°C	0.5		μV	
	$f = 0.1$ to $10\ \text{Hz}$	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	48°			

† Full range is -40°C to $+85^\circ\text{C}$.

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PARAMETER	TEST CONDITIONS	T_A †	TLC2202AI			TLC2202BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	500	80	500	μV		
		Full range	700			700			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5	$\mu\text{V}/^\circ\text{C}$		
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	0.001	0.005	$\mu\text{V}/\text{mo}$		
I_{IO} Input offset current		25°C	0.5	60	0.5	60	pA		
		Full range	150			150			
I_{IB} Input bias current		25°C	1	60	1	60	pA		
		Full range	150			150			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	–5 to 2.7		–5 to 2.7		V		
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	4.7	4.8	V		
		Full range	4.7			4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	–4.7	–4.9	–4.7	–4.9	V		
		Full range	–4.7			–4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	300	560	300	560	V/mV		
		Full range	150			150			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	50	100	50	100			
		Full range	25			25			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	25°C	80	115	80	115	dB		
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} \pm 2.3\ \text{V}$ to $\pm 8\ \text{V}$	25°C	80	110	80	110	dB		
		Full range	80			80			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.8	2.7	1.8	2.7	mA		
		Full range	2.7			2.7			

† Full range is -40°C to $+85^\circ\text{C}$.NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202I operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AI			TLC2202BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.8	2.7	1.8	2.7	$\text{V}/\mu\text{s}$		
		Full range	1.2			1.2			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\ \text{Hz}$	25°C	18	35	18	30	$\text{nV}/\sqrt{\text{Hz}}$		
	$f = 1\ \text{kHz}$	25°C	8	15	8	12			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1$ to $1\ \text{Hz}$	25°C	0.5			0.5	μV		
	$f = 0.1$ to $10\ \text{Hz}$	25°C	0.7			0.7			
I_n Equivalent input noise current		25°C	0.6			0.6	$\text{fA}/\sqrt{\text{Hz}}$		
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9			1.9	MHz		
ϕ_m Phase margin at unity gain	$R_l = 10\ \text{k}\Omega, C_l = 100\ \text{pF}$	25°C	48°			48°			

† Full range is -40°C to $+85^\circ\text{C}$.

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202I electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202I			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	1000	μV	
		Full range	1200			
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60	pA	
		Full range	150			
I_{IB} Input bias current		25°C	1	60	pA	
		Full range	150			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7	V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C	0	50	mV	
		Full range	50			
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	150	315	V/mV	
		Full range	100			
	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	15			
CMRR Common-mode rejection ratio	$V_O = 0, V_{IC} = V_{ICR\text{min}}, R_S = 50\ \Omega$	25°C	75	110	dB	
		Full range	75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\ \text{V to } 16\ \text{V}$	25°C	80	110	dB	
		Full range	80			
I_{DD} Supply current	$V_O = 2.5\ \text{V}, \text{ No load}$	25°C	1.7	2.6	mA	
		Full range	2.6			

† Full range is -40°C to $+85^\circ\text{C}$.NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202I operating characteristics at specified free-air temperature, $V_{DD} = 5\ \text{V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202I			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\ \text{V to } 2.5\ \text{V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.6	2.5	$\text{V}/\mu\text{s}$	
		Full range	1			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{to } 1\ \text{Hz}$	25°C	0.5		μV	
	$f = 0.1\ \text{to } 10\ \text{Hz}$	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	47°			

† Full range is -40°C to $+85^\circ\text{C}$.

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TLC2202I electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AI			TLC2202BI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage		25°C	80	500		80	500	μV	
		Full range			700		700		
α_{VIO} Temperature coefficient of input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	Full range	0.5			0.5			$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range	150			150			
I_{IB} Input bias current	25°C	1	60		1	60	pA		
	Full range	150			150				
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		0 to 2.7		V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	50	mV
		Full range	50			50			
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	100			100			
	$V_O = 1\text{ V to }4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		25	55		
		Full range	15			15			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	75	110		75	110	dB	
		Full range	75			75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	80	110		80	110	dB	
		Full range	80			80			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \text{ No load}$	25°C		1.7	2.6		1.7	2.6	mA
		Full range	2.6			2.6			

† Full range is -40°C to $+85^\circ\text{C}$ NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202I operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AI			TLC2202BI			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.6	2.5		1.6	2.5	V/ μs		
		Full range	1			1				
V_n Equivalent input noise voltage (see Note 5)	$f = 10\ \text{Hz}$	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8	15		8	12		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5			0.5			μV
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7			0.7			
I_n Equivalent input noise current		25°C		0.6			0.6			fA/ $\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.9			1.9			MHz
ϕ_m Phase margin at unity gain	$R_I = 10\ \text{k}\Omega, C_I = 100\ \text{pF}$	25°C		47°			47°			

† Full range is -40°C to $+85^\circ\text{C}$

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.



TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201M electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201M			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	100	500	μV	
		Full range	700			
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu\text{V}/\text{mo}$	
		25°C	0.5	60	pA	
I_{IO} Input offset current		Full range	500			
I_{IB} Input bias current		25°C	1	60	pA	
	Full range	500				
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	-5 to 2.7	V		
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	-4.7	-4.9	V	
		Full range	-4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	400	560	V/mV	
		Full range	200			
	$V_O = \pm 4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	90	100		
		Full range	45			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	25°C	90	115	dB	
		Full range	85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\text{ V to } \pm 8\text{ V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.1	1.5	mA	
		Full range	1.5			

† Full range is -55°C to 125°C .NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201M operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201M			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\text{ V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	2	2.7	$\text{V}/\mu\text{s}$	
		Full range	1.3			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C	18		$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{to } 1\ \text{Hz}$	25°C	0.5		μV	
	$f = 0.1\ \text{to } 10\ \text{Hz}$	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.9		MHz	
ϕ_m Phase margin	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	48°			

† Full range is -55°C to 125°C .

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TLC2201M electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AM			TLC2201BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50 \Omega$	25°C	80	200	80	200	μV		
		Full range	400		400				
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5		0.5		$\mu V/^\circ C$		
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	0.001	0.005	$\mu V/mo$		
I_{IO} Input offset current		25°C	0.5	60	0.5	60	pA		
		Full range	500		500				
I_{IB} Input bias current		25°C	1	60	1	60	pA		
	Full range	500		500					
V_{ICR} Common-mode input voltage range	$R_S = 50 \Omega$	Full range	-5 to 2.7	-5 to 2.7	-5 to 2.7	V			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10 k\Omega$	25°C	4.7	4.8	4.7	4.8	V		
		Full range	4.7		4.7				
V_{OM-} Maximum negative peak output voltage swing		25°C	-4.7	-4.9	-4.7	-4.9	V		
		Full range	-4.7		-4.7				
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4 V, R_L = 500 k\Omega$	25°C	400	560	400	560	V/mV		
		Full range	200		200				
	$V_O = \pm 4 V, R_L = 10 k\Omega$	25°C	90	100	90	100			
		Full range	45		45				
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50 \Omega$	25°C	90	115	90	115	dB		
		Full range	85		85				
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3 V$ to $\pm 8 V$	25°C	90	110	90	110	dB		
		Full range	85		85				
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.1	1.5	1.1	1.5	mA		
		Full range	1.5		1.5				

† Full range is $-55^\circ C$ to $125^\circ C$.

NOTE 4: Typical values are based on the input offset voltage shift observable through 168 hours of operating life test at $T_A = 150^\circ C$ extrapolated to $T_A = 25^\circ C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

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TLC2201M operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AM			TLC2201BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	2	2.7		2	2.7		V/ μs
		Full range	1.3			1.3			
V_n Equivalent input noise voltage (see Note 5)	f = 10 Hz	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$
	f = 1 kHz	25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C		0.5			0.5		μV
	f = 0.1 to 10 Hz	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6	fA/ $\sqrt{\text{Hz}}$	
Gain-bandwidth product	f = 10 kHz, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		1.9			1.9	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		48°			48°		

† Full range is -55°C to 125°C .

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201M electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201M			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C		100	500	μV
		Full range			700	
α_{VIO} Temperature coefficient of input offset voltage		Full range		0.5		$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C		0.001	0.005*	$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		25°C		0.5	60	pA
		Full range			500	
I_{IB} Input bias current		25°C		1	60	pA
		Full range			500	
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		V	
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0 50	mV	
		Full range		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	150	315	V/mV	
		Full range	75			
	$V_O = 1\text{ V to }4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	10			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICR\text{min}}, V_O = 0, R_S = 50\ \Omega$	25°C	90	110	dB	
		Full range	85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	90	110	dB	
		Full range	85			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \text{ No load}$	25°C		1 1.5	mA	
		Full range		1.5		

*On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C .

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201M operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201M			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.8	2.5	$\text{V}/\mu\text{s}$	
		Full range	1.1			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C		18	$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5	μV	
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7		
I_n Equivalent input noise current		25°C		0.6	$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.8	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		45°		

† Full range is -55°C to 125°C .



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TLC2201M electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AM			TLC2201BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	200		80	200	μV	
		Full range			400		400		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5		$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005		0.001	0.005	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range			500		500		
I_{IB} Input bias current	25°C	1	60		1	60	pA		
	Full range			500		500			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7			0 to 2.7	V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	V	
		Full range			50		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	75			75			
	$V_O = 1\ \text{V to } 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		25	55		
		Full range	10			10			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, V_O = 0, R_S = 50\ \Omega$	25°C	90	110		90	110	dB	
		Full range	85			85			
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\ \text{V to } 16\ \text{V}$	25°C	90	110		90	110	dB	
		Full range	85			85			
I_{DD} Supply current	$V_O = 2.5\ \text{V}, \text{ No load}$	25°C	1.1	1.5		1.1	1.5	mA	
		Full range			1.5		1.5		

† Full range is -55°C to 125°C .NOTE 4: Typical values are based on the input offset voltage shift observable through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201M operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2201AM			TLC2201BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	1.8	2.5		1.8	2.5		V/ μs
		Full range	1.1			1.1			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$ $f = 1\text{ kHz}$	25°C		18	35		18	30	nV/ $\sqrt{\text{Hz}}$
		25°C		8	15		8	12	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$ $f = 0.1\text{ to }10\text{ Hz}$	25°C		0.5			0.5		μV
		25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6	fA/ $\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		1.8			1.8	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		45°			45°		

† Full range is -55°C to 125°C .

NOTE 5: This parameter is tested on a sample basis for the TLC2201A and on all devices for the TLC2201B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202M electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202M			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50 \Omega$	25°C	100	1000	μV	
		Full range	1250			
$\alpha_{V_{IO}}$ Temperature coefficient of input offset voltage		Full range	0.5		$\mu V/^\circ C$	
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005	$\mu V/mo$	
I_{IO} Input offset current		25°C	0.5	60	pA	
		Full range	500			
I_{IB} Input bias current		25°C	1	60	pA	
		Full range	500			
V_{ICR} Common-mode input voltage range	$R_S = 50 \Omega$	Full range	-5 to 2.7	V		
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10 k\Omega$	25°C	4.7	4.8	V	
V_{OM-} Maximum negative peak output voltage swing		Full range	4.7			
		25°C	-4.7	-4.9	V	
Full range		-4.7				
A_{VD} Large-signal differential voltage amplification	$V_O = 1$ V to 4 V, $R_L = 500 k\Omega$	25°C	300	560	V/mV	
		Full range	100			
	$V_O = 1$ V to 4 V, $R_L = 10 k\Omega$	25°C	50	100		
		Full range	25			
CMRR Common-mode rejection ratio	$V_O = 0, V_{IC} = V_{ICRmin}, R_S = 50 \Omega$	25°C	80	115	dB	
		Full range	80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = \pm 2.3$ V to ± 8 V	25°C	80	110	dB	
		Full range	80			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.8	2.7	mA	
		Full range	2.7			

* On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is $-55^\circ C$ to $125^\circ C$.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ C$ extrapolated to $T_A = 25^\circ C$ using Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202M operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5$ V

PARAMETER	TEST CONDITIONS	T_A †	TLC2202M			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10 k\Omega, C_L = 100$ pF	25°C	1.8	2.7	$V/\mu s$	
		Full range	1.1			
V_n Equivalent input noise voltage	$f = 10$ Hz	25°C	18		nV/\sqrt{Hz}	
	$f = 1$ kHz	25°C	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1$ to 1 Hz	25°C	0.5		μV	
	$f = 0.1$ to 10 Hz	25°C	0.7			
I_n Equivalent input noise current		25°C	0.6		fA/\sqrt{Hz}	
Gain-bandwidth product	$f = 10$ kHz, $R_L = 10 k\Omega, C_L = 100$ pF	25°C	1.9		MHz	
ϕ_m Phase margin at unity gain	$R_L = 10 k\Omega, C_L = 100$ pF	25°C	48°			

† Full range is $-55^\circ C$ to $125^\circ C$.



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TLC2202M electrical characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AM			TLC2202BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage		25°C	80	500		80	500	μV	
		Full range		750		750			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.5			0.5			$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	0.001	0.005*		0.001	0.005*	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range		500		500			
I_{IB} Input bias current		25°C	1	60		1	60	pA	
		Full range		500		500			
V_{ICR} Common-mode input voltage range		$R_S = 50\ \Omega$	Full range	–5 to 2.7			–5 to 2.7		
V_{OM+} Maximum positive peak output voltage swing	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OM-} Maximum negative peak output voltage swing		25°C	–4.7	–4.9		–4.7	–4.9	V	
		Full range	–4.7			–4.7			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 4\ \text{V}, R_L = 500\ \text{k}\Omega$	25°C	300	560		300	560	V/mV	
		Full range	100			100			
	$V_O = \pm 4\ \text{V}, R_L = 10\ \text{k}\Omega$	25°C	50	100		50	100		
		Full range	25			25			
CMRR Common-mode rejection ratio	$V_O = 0, V_{IC} = V_{ICRmin}, R_S = 50\ \Omega$	25°C	80	115		80	115	dB	
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD\pm} = \pm 2.3\ \text{V to } \pm 8\ \text{V}$	25°C	80	110		80	110	dB	
		Full range	80			80			
I_{DD} Supply current	$V_O = 0, \text{ No load}$	25°C	1.8	2.7		1.8	2.7	mA	
		Full range		2.7			2.7		

*On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C .

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

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TLC2202M operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AM			TLC2202BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain $V_O = \pm 2.3\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	1.8	2.7		1.8	2.7		$\text{V}/\mu\text{s}$
		Full range	1.1			1.1			
V_n	Equivalent input noise voltage (see Note 5)	f = 10 Hz		18	35*		18	30*	$\text{nV}/\sqrt{\text{Hz}}$
		f = 1 kHz		8	15*		8	12*	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz		0.5			0.5		μV
		f = 0.1 to 10 Hz		0.7			0.7		
I_n	Equivalent input noise current	25°C		0.6			0.6	$\text{fA}/\sqrt{\text{Hz}}$	
	Gain-bandwidth product	f = 10 kHz, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$		1.9			1.9	MHz	
ϕ_m	Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$		48°			48°		

*On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C .

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2202M electrical characteristics at specified free-air temperatures, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202M			UNIT
			MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C		100	1000	μV
		Full range			1250	
α_{VIO} Temperature coefficient of input offset voltage		Full range		0.5		$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C		0.001	0.005*	$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		25°C		0.5	60	pA
		Full range			500	
I_{IB} Input bias current		25°C		1	60	pA
		Full range			500	
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		V	
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8	V	
		Full range	4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0 50	mV	
		Full range		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	150	315	V/mV	
		Full range	75			
	$V_O = 1\text{ V to }4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		
		Full range	10			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50\ \Omega$	25°C	75	110	dB	
		Full range	75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	80	110	dB	
		Full range	80			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \text{ No load}$	25°C		1.7 2.6	mA	
		Full range		2.6		

* On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C .

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202M operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202M			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C	1.6	2.5	$\text{V}/\mu\text{s}$	
		Full range	0.9			
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	25°C		18	$\text{nV}/\sqrt{\text{Hz}}$	
	$f = 1\ \text{kHz}$	25°C		8		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\ \text{Hz}$	25°C		0.5	μV	
	$f = 0.1\text{ to }10\ \text{Hz}$	25°C		0.7		
I_n Equivalent input noise current		25°C		0.6	$\text{fA}/\sqrt{\text{Hz}}$	
Gain-bandwidth product	$f = 10\ \text{kHz}, R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		1.9	MHz	
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega, C_L = 100\ \text{pF}$	25°C		47°		

† Full range is -55°C to 125°C .



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TLC2202M electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AM			TLC2202BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	80	500		80	500	μV	
		Full range			750		750		
αV_{IO} Temperature coefficient of input offset voltage		Full range	0.5			0.5			$\mu\text{V}/^\circ\text{C}$
Input offset voltage long-term drift (see Note 4)		25°C	0.001	0.005*		0.001	0.005*	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	0.5	60		0.5	60	pA	
		Full range			500		500		
I_{IB} Input bias current		25°C	1	60		1	60	pA	
		Full range			500		500		
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	Full range	0 to 2.7		0 to 2.7		V		
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	25°C	4.7	4.8		4.7	4.8	V	
		Full range	4.7			4.7			
V_{OL} Maximum low-level output voltage	$I_O = 0$	25°C		0	50		0	mV	
		Full range			50		50		
A_{VD} Large-signal differential voltage amplification	$V_O = 1\text{ V to }4\text{ V}, R_L = 500\ \text{k}\Omega$	25°C	150	315		150	315	V/mV	
		Full range	75			75			
	$V_O = 1\text{ V to }4\text{ V}, R_L = 10\ \text{k}\Omega$	25°C	25	55		25	55		
		Full range	10			10			
CMRR Common-mode rejection ratio	$V_O = 0, V_{IC} = V_{ICR\text{min}}, R_S = 50\ \Omega$	25°C	75	110		75	110	dB	
		Full range	75			75			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD\pm}/\Delta V_{IO}$)	$V_{DD} = 4.6\text{ V to }16\text{ V}$	25°C	80	110		80	110	dB	
		Full range	80			80			
I_{DD} Supply current	$V_O = 2.5\text{ V}, \text{ No load}$	25°C		1.7	2.6		1.7	mA	
		Full range			2.6		2.6		

*On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

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TLC2202M operating characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLC2202AM			TLC2202BM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$V_O = 0.5\text{ V to }2.5\text{ V}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	1.6	2.5		1.6	2.5		$\text{V}/\mu\text{s}$
		Full range	0.9			1.1			
V_n Equivalent input noise voltage (see Note 5)	$f = 10\text{ Hz}$	25°C		18	35*		18	30*	$\text{nV}/\sqrt{\text{Hz}}$
	$f = 1\text{ kHz}$	25°C		8	15*		8	12*	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ to }1\text{ Hz}$	25°C		0.5			0.5		μV
	$f = 0.1\text{ to }10\text{ Hz}$	25°C		0.7			0.7		
I_n Equivalent input noise current		25°C		0.6			0.6		$\text{fA}/\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\text{ kHz}$, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		1.9			1.9		MHz
ϕ_m Phase margin at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C		47°			47°		

* On products compliant to MIL-PRF-38535, Class B, this parameter is not production tested.

† Full range is -55°C to 125°C

NOTE 5: This parameter is tested on a sample basis for the TLC2202A and on all devices for the TLC2202B. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TLC2201Y electrical characteristics at $V_{DD\pm} = \pm 5\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLC2201Y			UNIT
		MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0$, $R_S = 50\ \Omega$	100			μV
Input offset voltage long-term drift (see Note 4)		0.001			$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		0.5			pA
I_{IB} Input bias current		1			pA
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$	4.8			V
V_{OL} Maximum low-level output voltage	$I_O = 0$	0			mV
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}$, $R_L = 500\ \Omega$	55			V/mV
	$V_O = 1\ \text{V to } 4\ \text{V}$, $R_L = 10\ \Omega$	55			
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $V_O = 0$, $R_S = 50\ \Omega$	110			dB
k_{SVR} Supply voltage rejection ratio ($\Delta V_{DD\pm} / \Delta V_{IO}$)	$V_{DD} = 4.6\ \text{to } 16\ \text{V}$	110			dB
I_{DD} Supply current per amplifier	$V_O = 2.5\ \text{V}$, No load	1			mA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2201Y operating characteristics at $V_{DD\pm} = \pm 5\ \text{V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC2201Y			UNIT
		MIN	TYP	MAX	
SR Positive slew rate at unity gain	$V_O = \pm 0.5\ \text{to } 2.5\ \text{V}$, $R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$	2.5			$\text{V}/\mu\text{s}$
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$	18			$\text{nV}/\sqrt{\text{Hz}}$
	$f = 1\ \text{kHz}$	8			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{to } 1\ \text{Hz}$	0.5			μV
	$f = 0.1\ \text{to } 10\ \text{Hz}$	0.7			
I_n Equivalent input noise current		0.6			$\text{pA}/\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\ \text{kHz}$, $R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$	1.8			MHz
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$	48°			

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TLC2202Y electrical characteristics, $V_{DD} = 5\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLC2202Y			UNIT
		MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0$, $R_S = 50\ \Omega$		100		μV
Input offset voltage long-term drift (see Note 4)			0.001		$\mu\text{V}/\text{mo}$
I_{IO} Input offset current			0.5		pA
I_{IB} Input bias current			1		pA
V_{OH} Maximum high-level output voltage	$R_L = 10\ \text{k}\Omega$		4.8		V
V_{OL} Maximum low-level output voltage	$I_O = 0$		0		mV
A_{VD} Large-signal differential voltage amplification	$V_O = 1\ \text{V to } 4\ \text{V}$, $R_L = 500\ \Omega$		315		V/mV
	$V_O = 1\ \text{V to } 4\ \text{V}$, $R_L = 10\ \Omega$		55		
CMRR Common-mode rejection ratio	$V_O = 0$, $V_{ICR\text{min}}$, $R_S = 50\ \Omega$		110		dB
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DCC}/\Delta V_{IO}$)	$V_{DD} = 4.6\ \text{ to } 16\ \text{V}$		110		dB
I_{DD} Supply current	$V_O = 2.5\ \text{V}$, No load		1.7		mA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLC2202Y operating characteristics at $V_{DD} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC2202Y			UNIT
		MIN	TYP	MAX	
SR Positive slew rate at unity gain	$V_O = 0.5\ \text{V to } 2.5\ \text{V}$, $R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$		2.5		$\text{V}/\mu\text{s}$
V_n Equivalent input noise voltage	$f = 10\ \text{Hz}$		18		$\text{nV}/\sqrt{\text{Hz}}$
	$f = 10\ \text{kHz}$		8		
$V_{N(\text{PP})}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{ to } 1\ \text{Hz}$		0.5		μV
	$f = 0.1\ \text{ to } 10\ \text{Hz}$		0.7		
I_n Equivalent input noise current			0.6		$\text{pA}/\sqrt{\text{Hz}}$
B_1 Gain-bandwidth product	$f = 10\ \text{kHz}$, $C_L = 100\ \text{pF}$, $R_L = 10\ \text{k}\Omega$		1.9		MHz
ϕ_m Phase margin at unity gain	$R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$		47°		

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PARAMETER MEASUREMENT INFORMATION

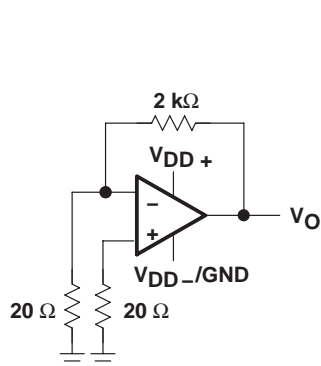


Figure 1. Noise-Voltage Test Circuit

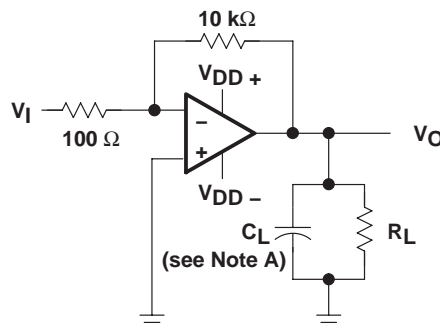
NOTE A: C_L includes fixture capacitance.

Figure 2. Phase-Margin Test Circuit

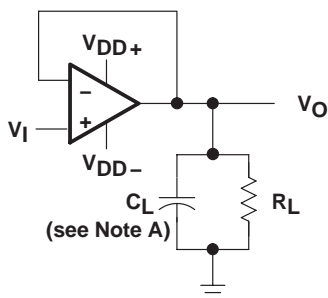
NOTE A: C_L includes fixture capacitance.

Figure 3. Slew-Rate Test Circuit

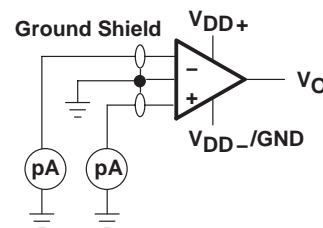


Figure 4. Input-Bias and Offset-Current Test Circuit

typical values

Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

input bias and offset current

At the picoamp bias current level of the TLC220x, TLC220xA, and TLC220xB, accurate measurement of the bias current becomes difficult. Not only does this measurement require a picoammeter, but test socket leakages can easily exceed the actual device bias currents. To measure these small currents, Texas Instruments uses a two-step process. The socket leakage is measured using picoammeters with bias voltages applied but with no device in the socket. The device is then inserted in the socket, and a second test measuring both the socket leakage and the device input bias current is performed. The two measurements are then subtracted algebraically to determine the bias current of the device.

noise

Texas Instruments offers automated production noise testing to meet individual application requirements. Noise voltage at $f = 10$ Hz and $f = 1$ kHz is 100% tested on every TLC2201B device, while lot sample testing is performed on the TLC220xA. For other noise requirements, please contact the factory.

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TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
V_{IO}	Input offset voltage	Distribution	5, 6
I_{IB}	Input bias current	vs Common-mode input voltage	7
		vs Free-air temperature	8
V_{OM}	Maximum peak output voltage	vs Output current	9
		vs Free-air temperature	10
$V_{O(PP)}$	Maximum peak-to-peak output voltage	vs Frequency	11
V_{OH}	High-level output voltage	vs Frequency	12
		vs High-level output current	13
		vs Free-air temperature	14
V_{OL}	Low-level output voltage	vs Low-level output current	15
		vs Free-air temperature	16
A_{VD}	Large-signal differential voltage amplification	vs Frequency	17
		vs Free-air temperature	18
I_{OS}	Short-circuit output current	vs Supply voltage	19
		vs Free-air temperature	20
$CMRR$	Common-mode rejection ratio	vs Frequency	21
I_{DD}	Supply current	vs Supply voltage	22
		vs Free-air temperature	23, 24
	Pulse response	Small signal	25, 26
		Large signal	27, 28
SR	Slew rate	vs Supply voltage	29
		vs Free-air temperature	30
	Noise voltage (referred to input)	0.1 to 1 Hz	31
		0.1 to 10 Hz	32
	Gain-bandwidth product	vs Supply voltage	33, 34
		vs Free-air temperature	35
ϕ_m	Phase margin	vs Supply voltage	36, 37
		vs Free-air temperature	38, 39
	Phase shift	vs Frequency	17

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TYPICAL CHARACTERISTICS

**DISTRIBUTION OF TLC2201
INPUT OFFSET VOLTAGE**

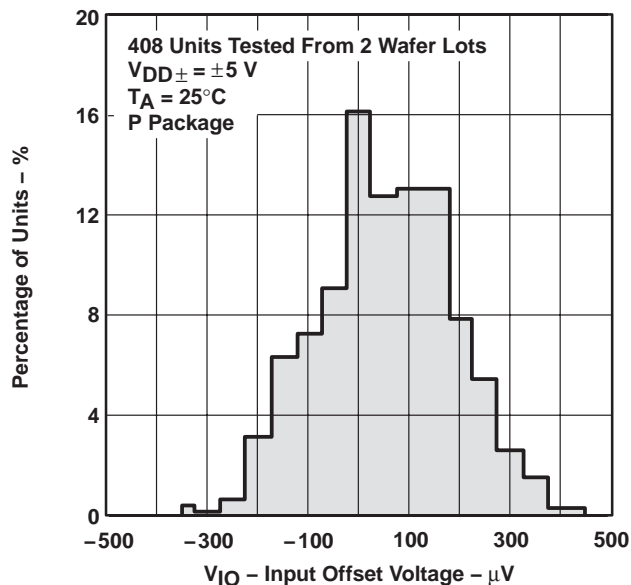


Figure 5

**TLC2202
DISTRIBUTION OF
INPUT OFFSET VOLTAGE**

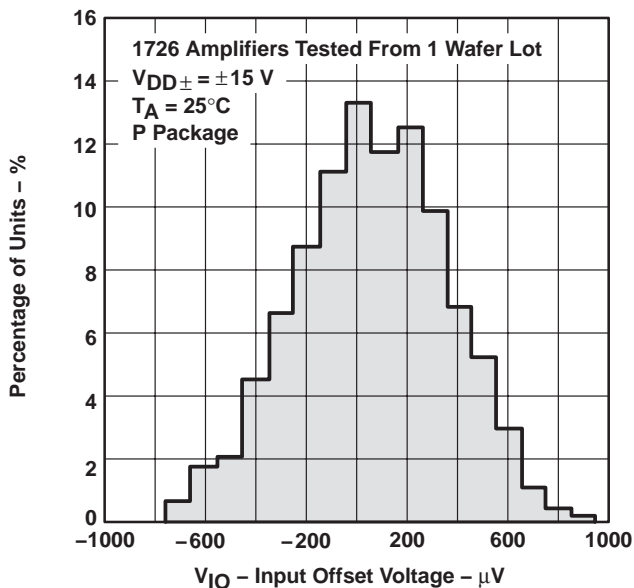


Figure 6

**INPUT BIAS CURRENT
vs
COMMON-MODE INPUT VOLTAGE**

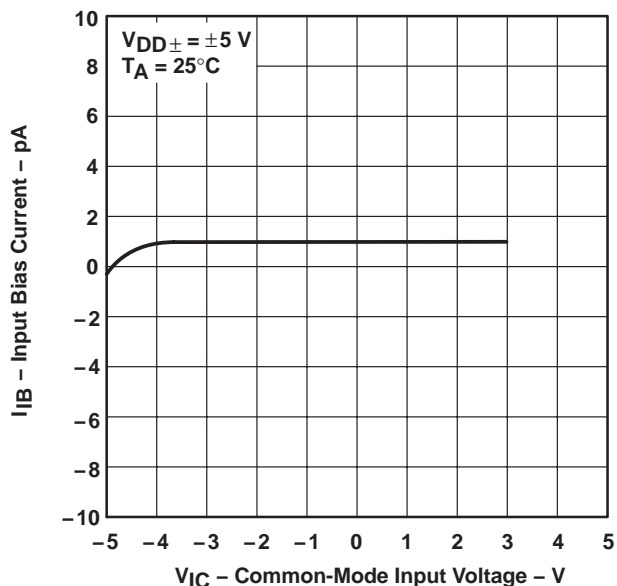


Figure 7

**INPUT BIAS CURRENT†
vs
FREE-AIR TEMPERATURE**

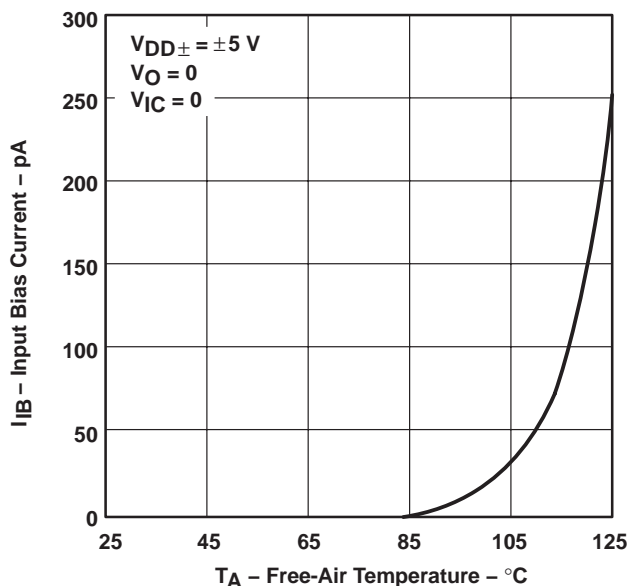


Figure 8

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

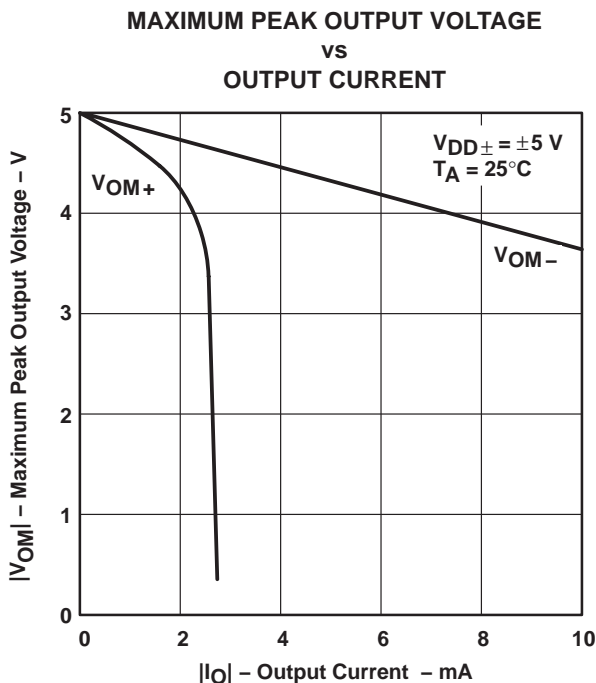


Figure 9

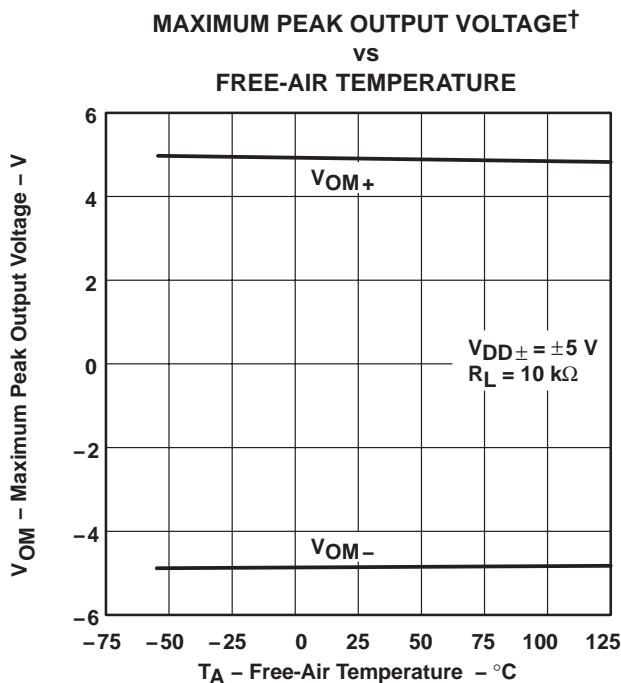


Figure 10

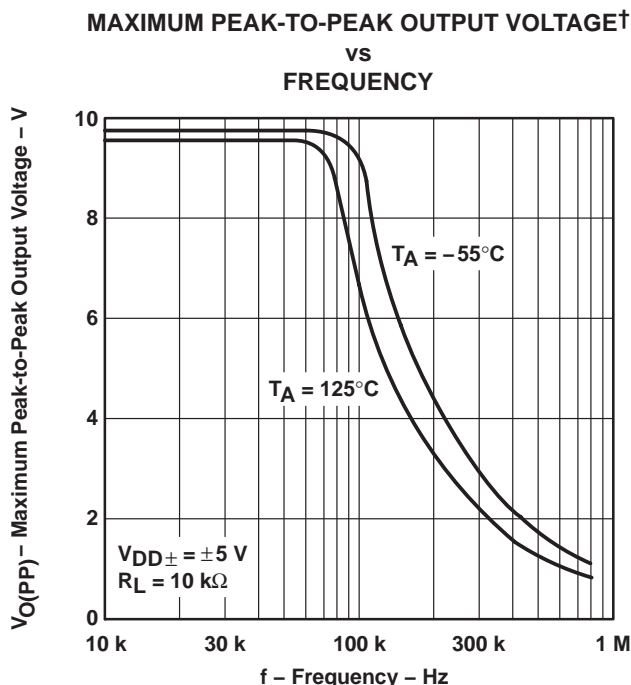


Figure 11

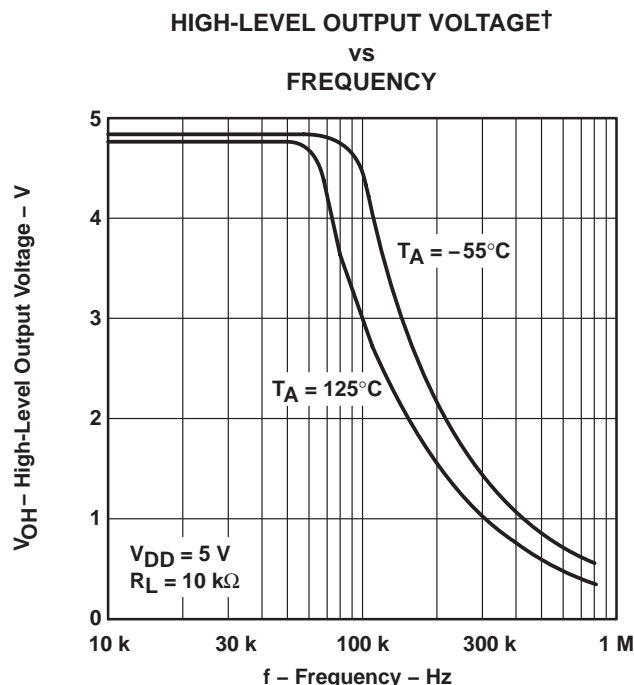


Figure 12

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TYPICAL CHARACTERISTICS

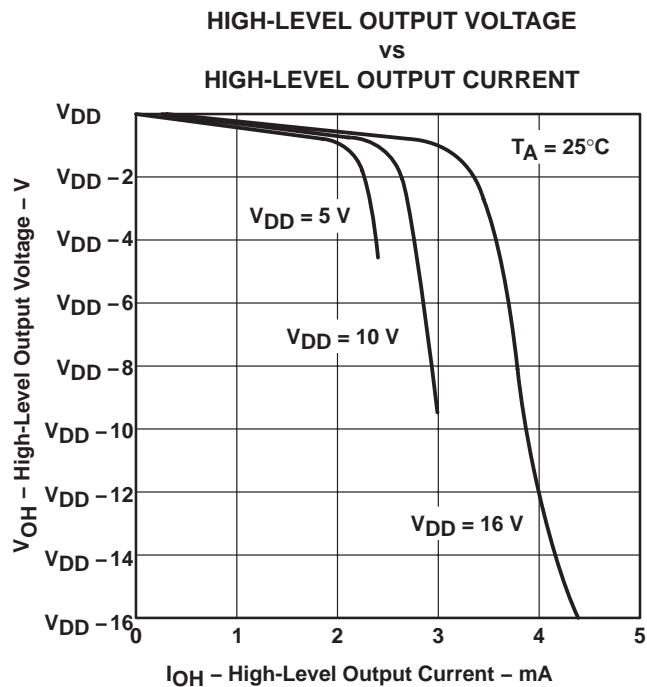


Figure 13

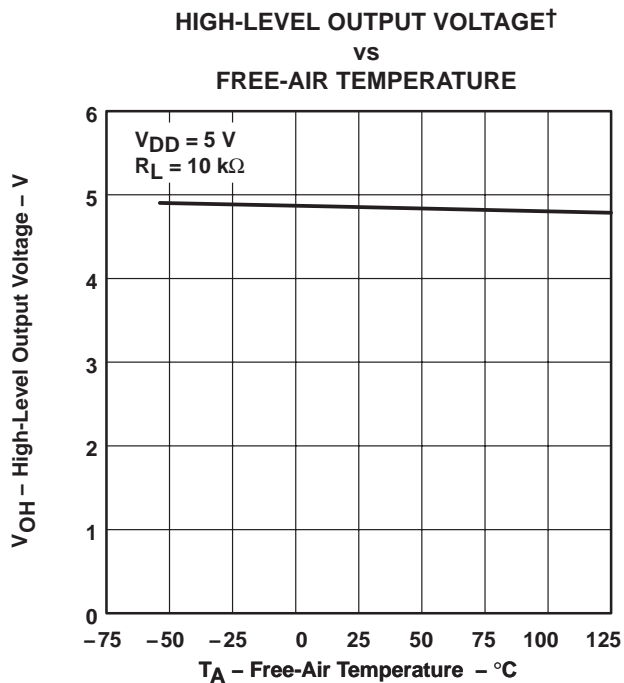


Figure 14

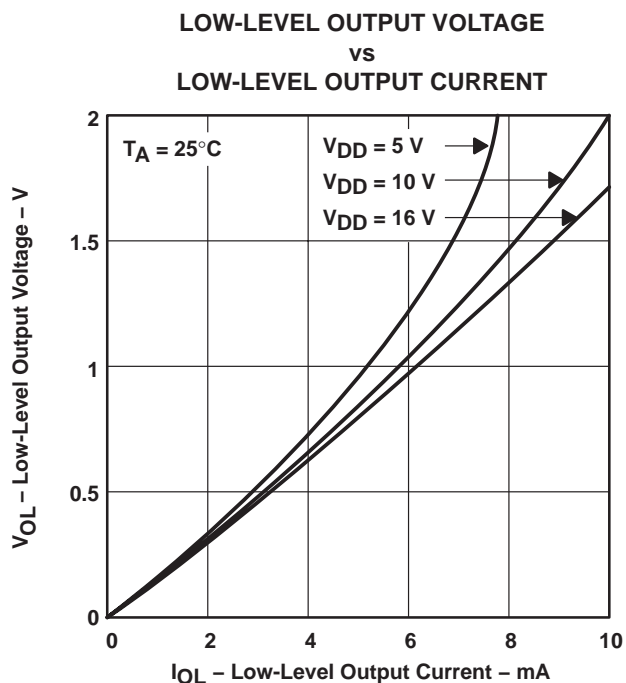


Figure 15

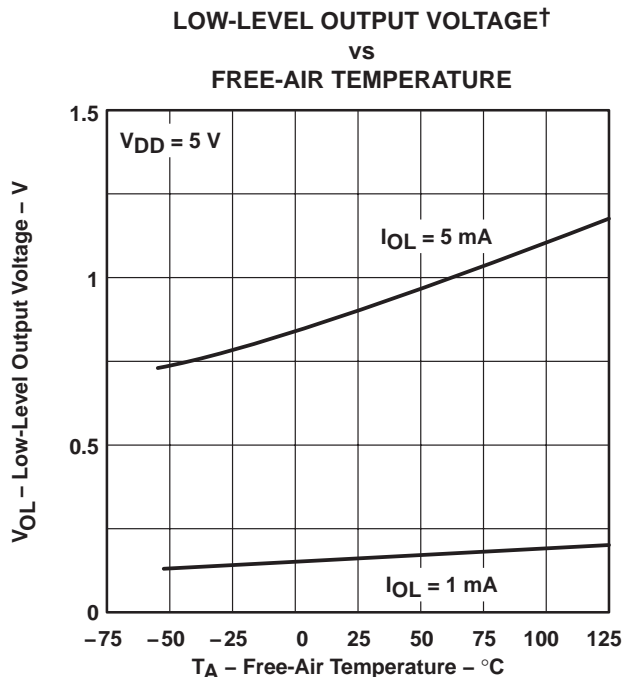


Figure 16

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT vs FREQUENCY

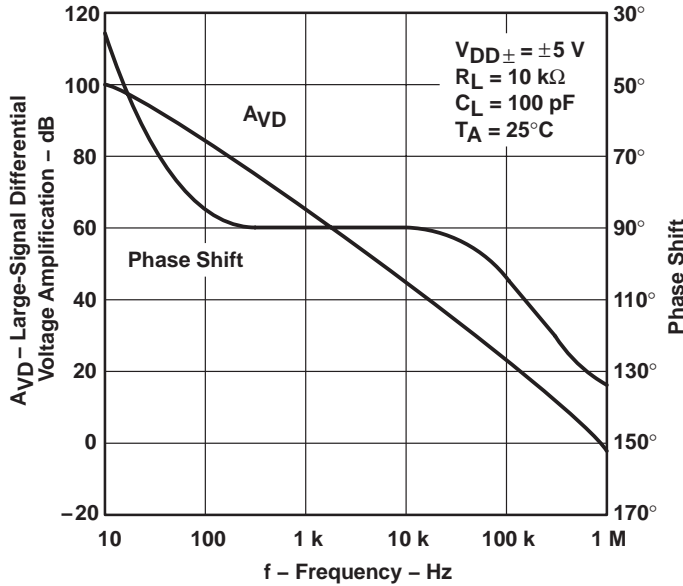


Figure 17

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION† vs FREE-AIR TEMPERATURE

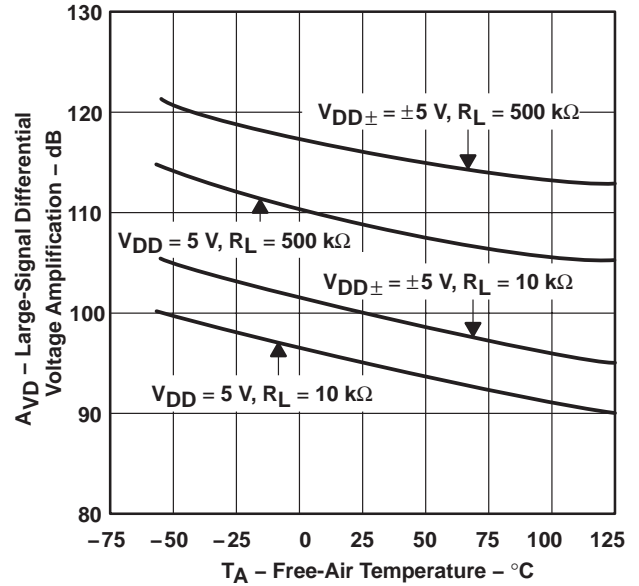


Figure 18

SHORT-CIRCUIT OUTPUT CURRENT vs SUPPLY VOLTAGE

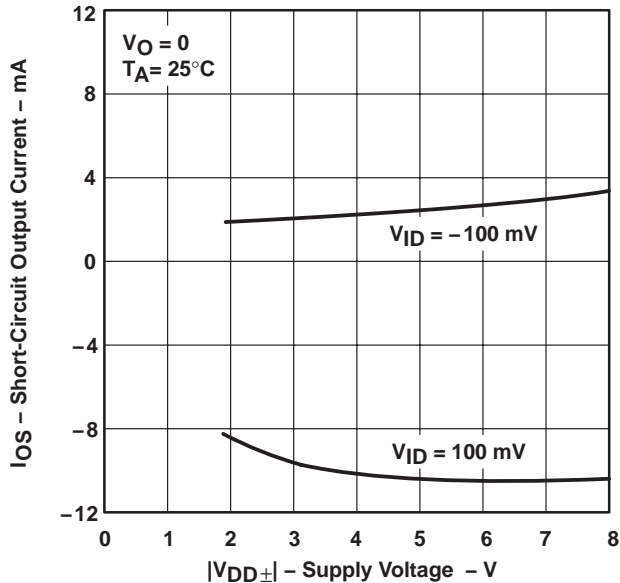


Figure 19

SHORT-CIRCUIT OUTPUT CURRENT† vs FREE-AIR TEMPERATURE

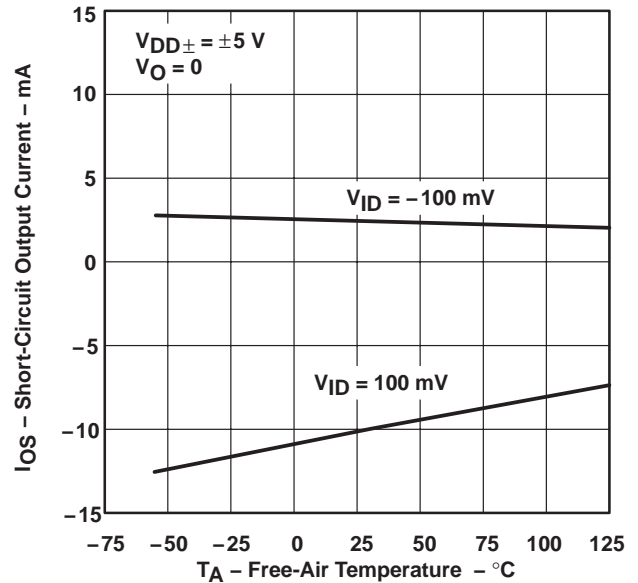


Figure 20

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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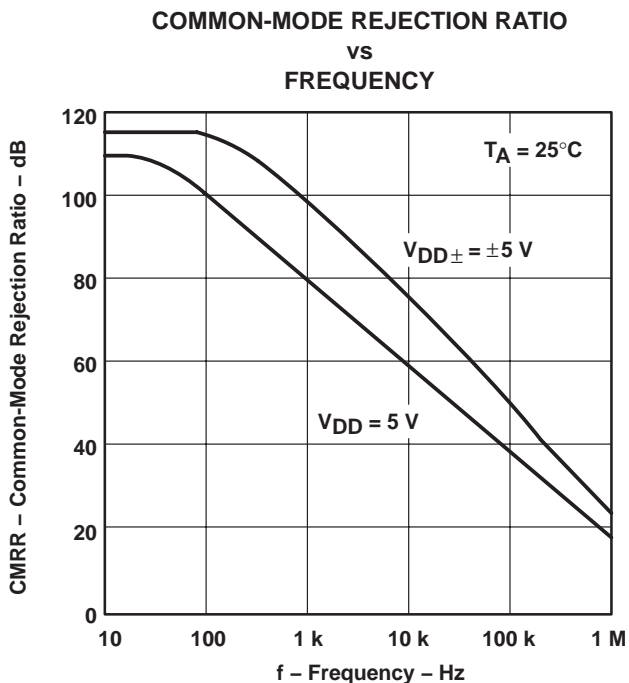


Figure 21

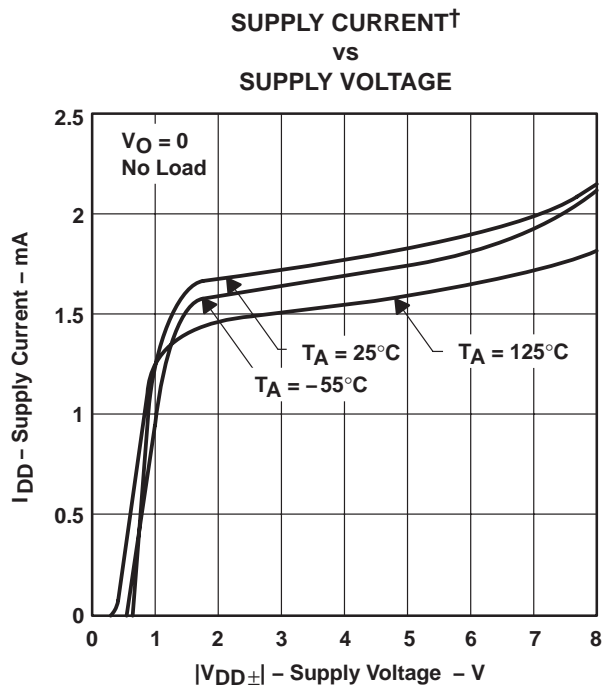


Figure 22

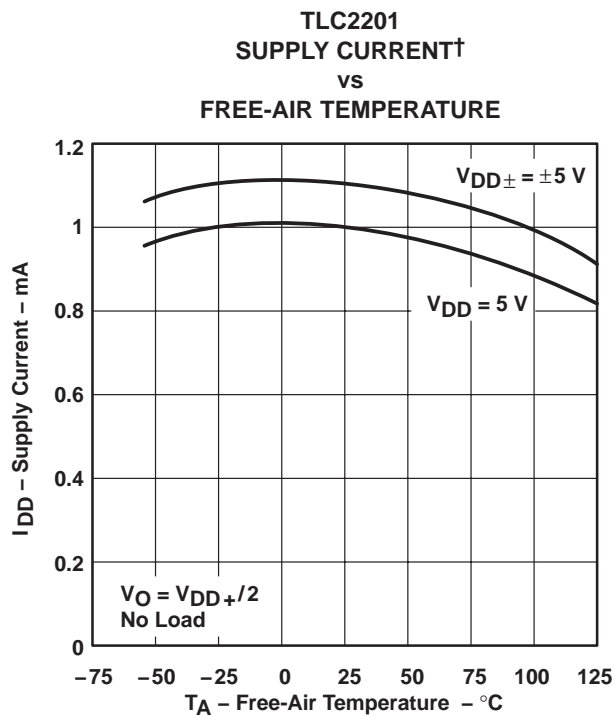


Figure 23

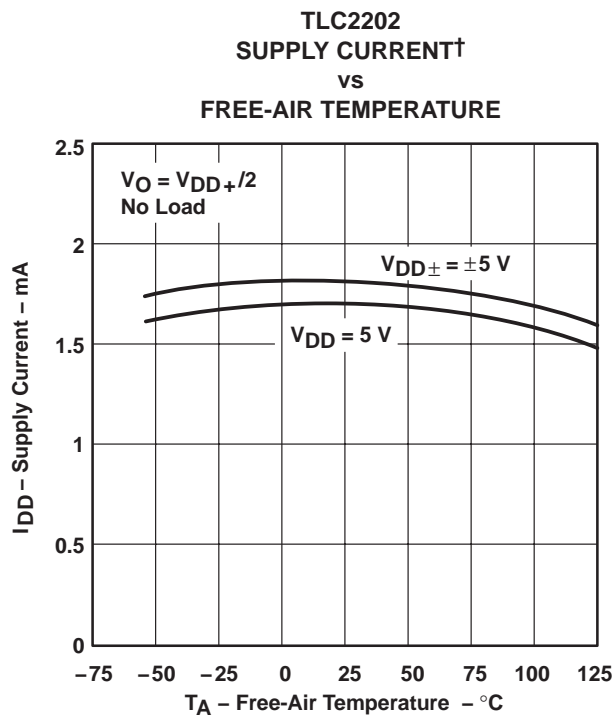


Figure 24

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**VOLTAGE-FOLLOWER
 SMALL-SIGNAL
 PULSE RESPONSE**

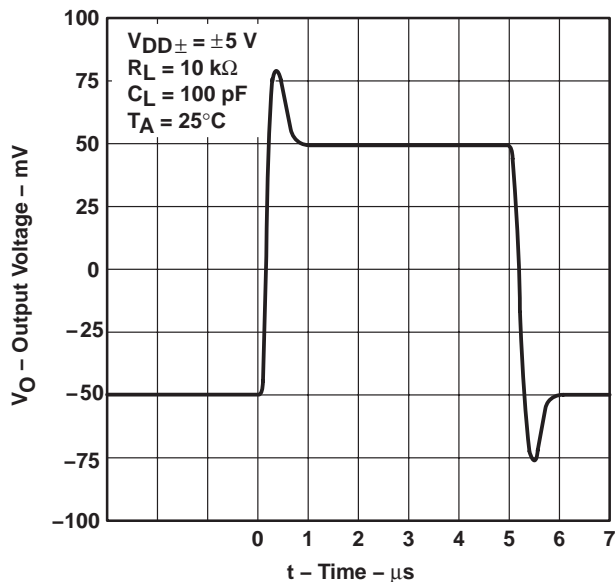


Figure 25

**VOLTAGE-FOLLOWER
 SMALL-SIGNAL
 PULSE RESPONSE**

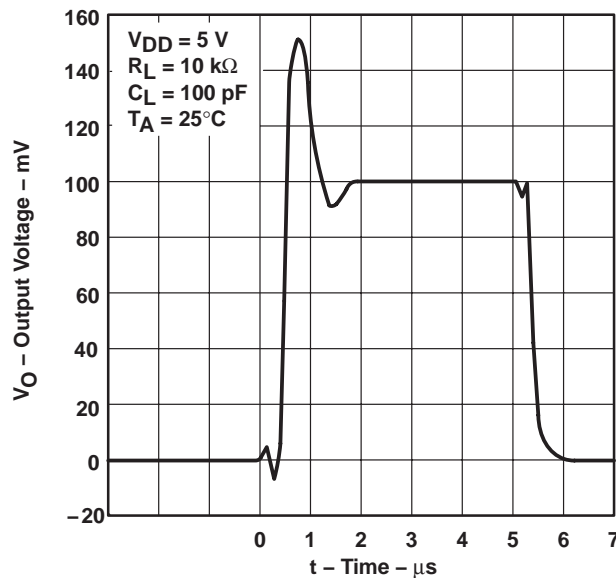


Figure 26

**VOLTAGE-FOLLOWER
 LARGE-SIGNAL
 PULSE RESPONSE**

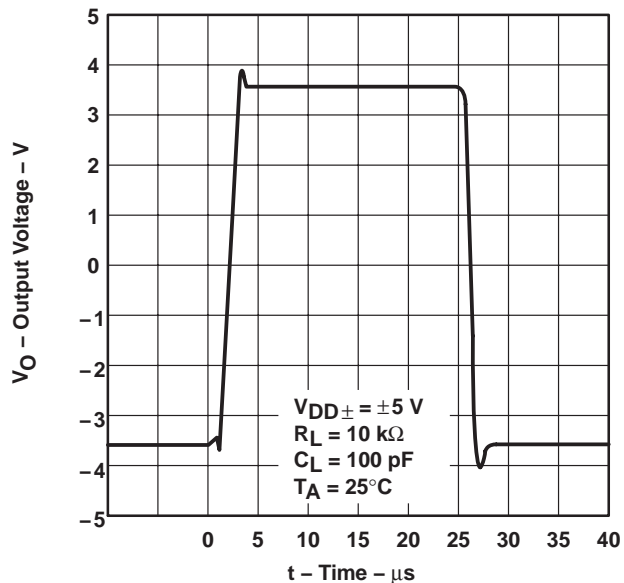


Figure 27

**VOLTAGE-FOLLOWER
 LARGE-SIGNAL
 PULSE RESPONSE**

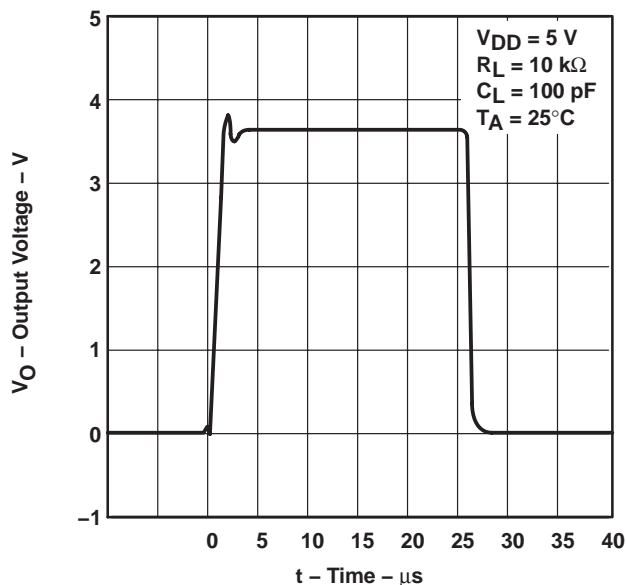


Figure 28

TLC220x, TLC220xA, TLC220xB, TLC220xY

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TYPICAL CHARACTERISTICS

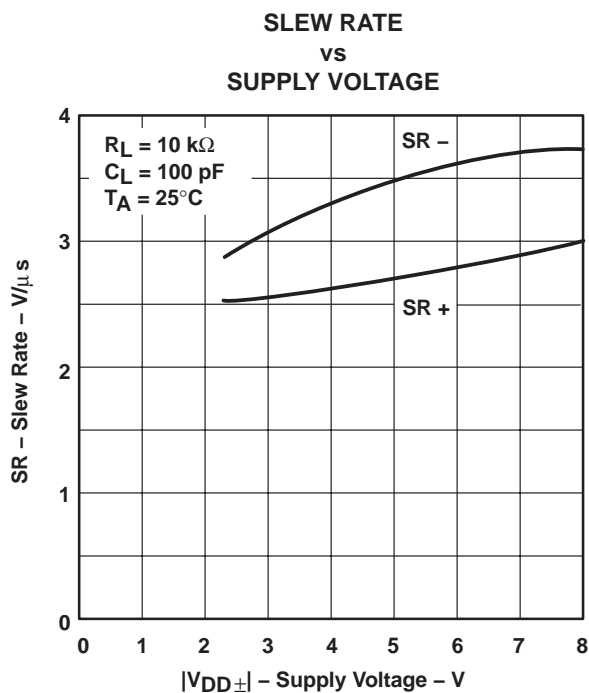


Figure 29

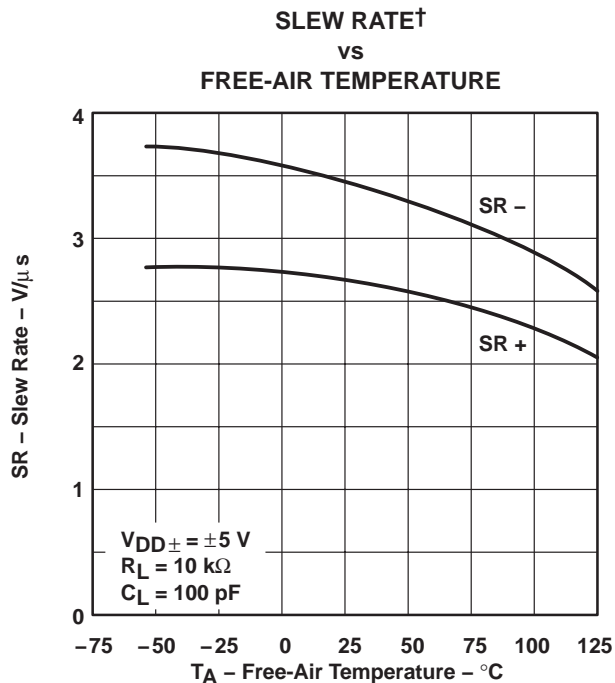


Figure 30

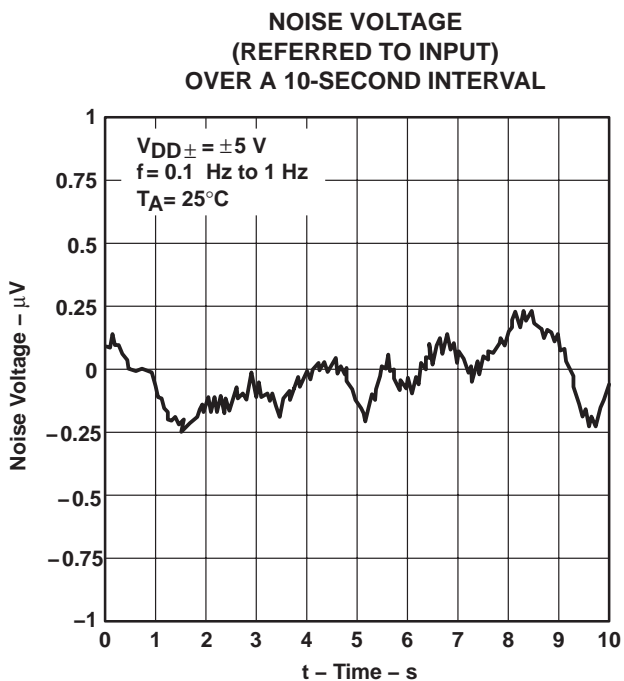


Figure 31

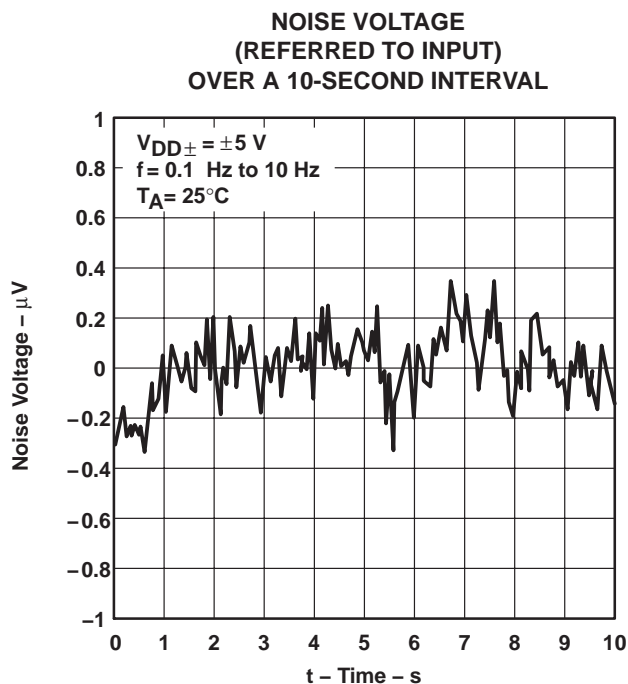


Figure 32

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLC2201
GAIN-BANDWIDTH PRODUCT
vs
SUPPLY VOLTAGE

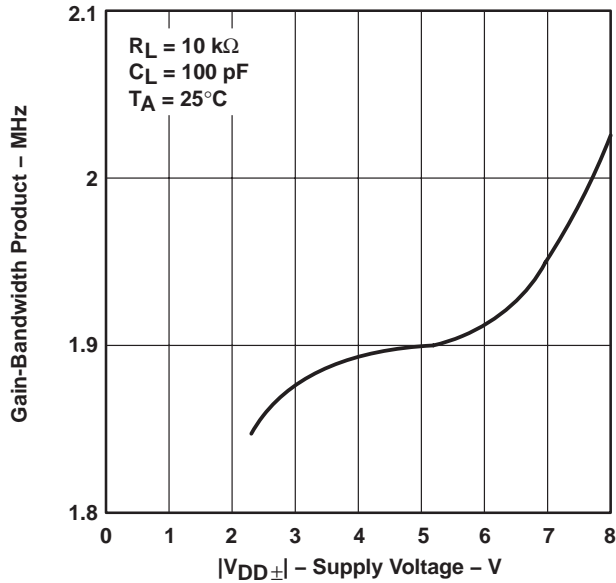


Figure 33

TLC2202
GAIN-BANDWIDTH PRODUCT
vs
SUPPLY VOLTAGE

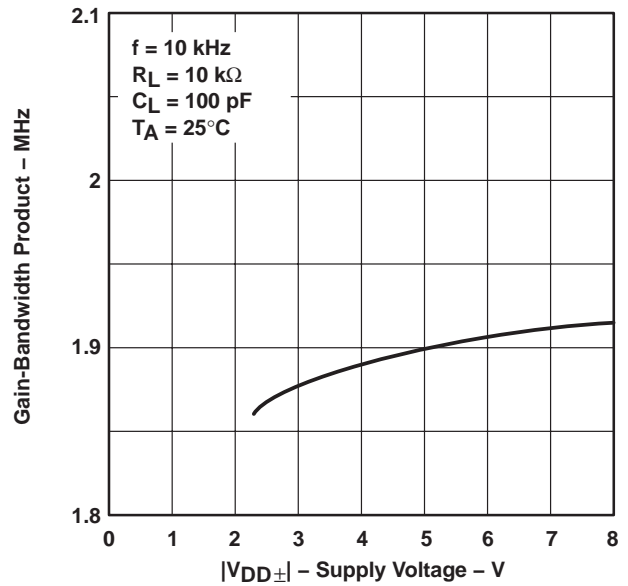


Figure 34

GAIN-BANDWIDTH PRODUCT†
vs
FREE-AIR TEMPERATURE

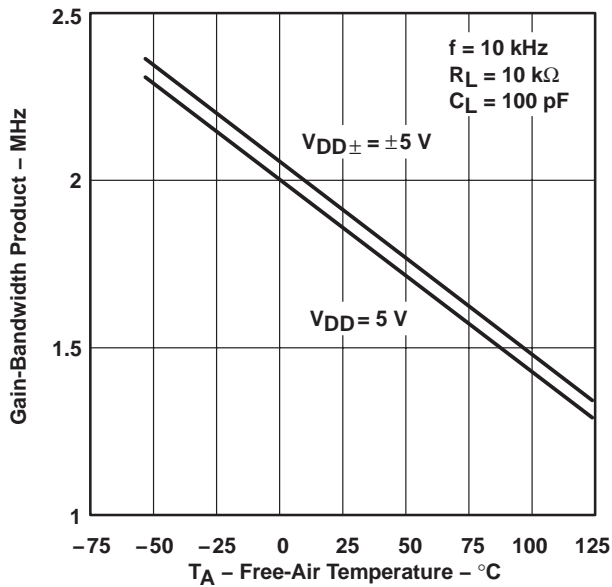


Figure 35

TLC2201
PHASE MARGIN
vs
SUPPLY VOLTAGE

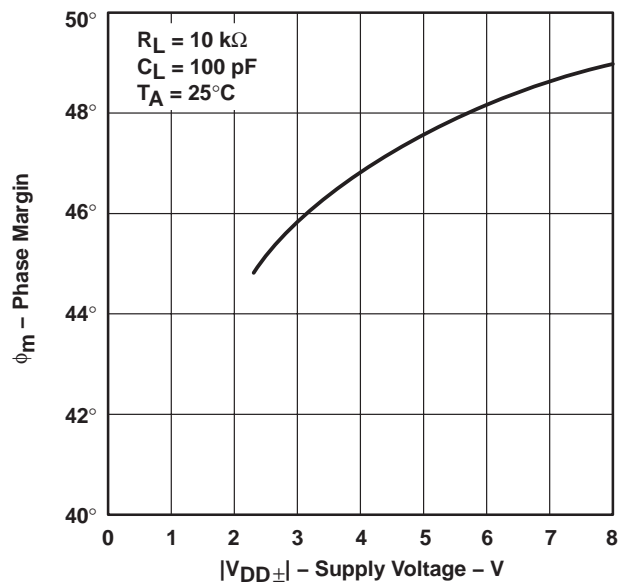


Figure 36

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS

**TLC2202
PHASE MARGIN
vs
SUPPLY VOLTAGE**

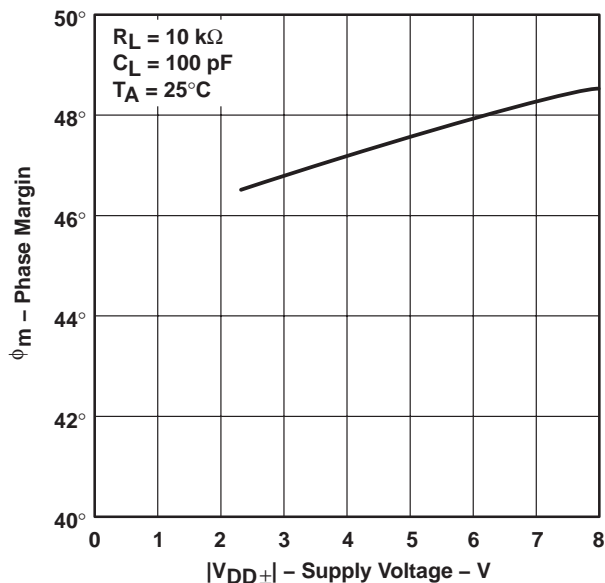


Figure 37

**TLC2201
PHASE MARGIN†
vs
FREE-AIR TEMPERATURE**

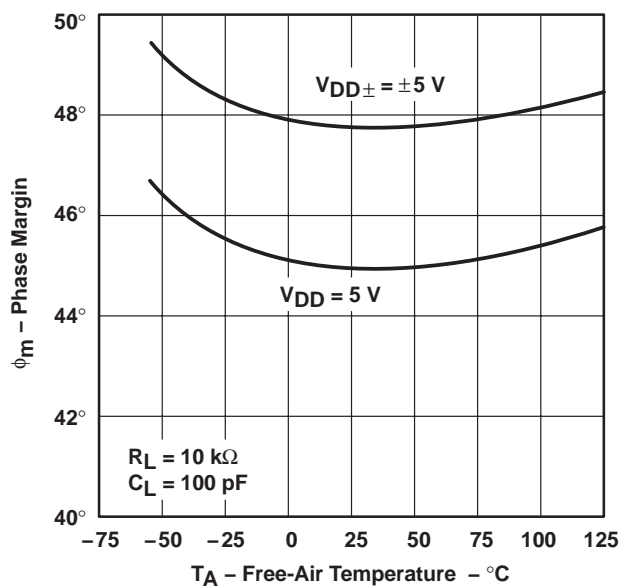


Figure 38

**TLC2202
PHASE MARGIN†
vs
FREE-AIR TEMPERATURE**

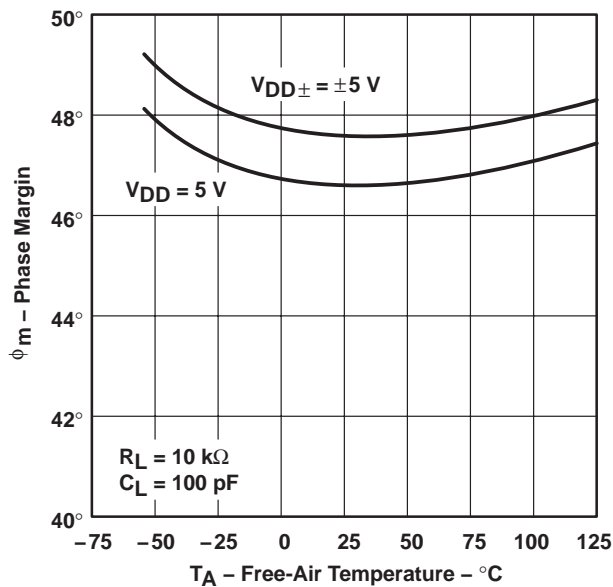


Figure 39

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

latch-up avoidance

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC220x, TLC220xA, and TLC220xB inputs and outputs are designed to withstand –100-mA surge currents without sustaining latch-up; however, techniques reducing the chance of latch-up should be used whenever possible. Internal protection diodes should not be forward biased in normal operation. Applied input and output voltages should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

electrostatic discharge protection

These devices use internal ESD-protection circuits that prevent functional failures at voltages at or below 2000 V. Care should be exercised in handling these devices as exposure to ESD may result in degradation of the device parametric performance.

macromodel information

Macromodel information provided was derived using Microsim *Parts*™, the model generation software used with Microsim *PSpice*™. The Boyle macromodel (see Note 5) and subcircuit in Figure 40 were generated using the TLC220x typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 5: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).

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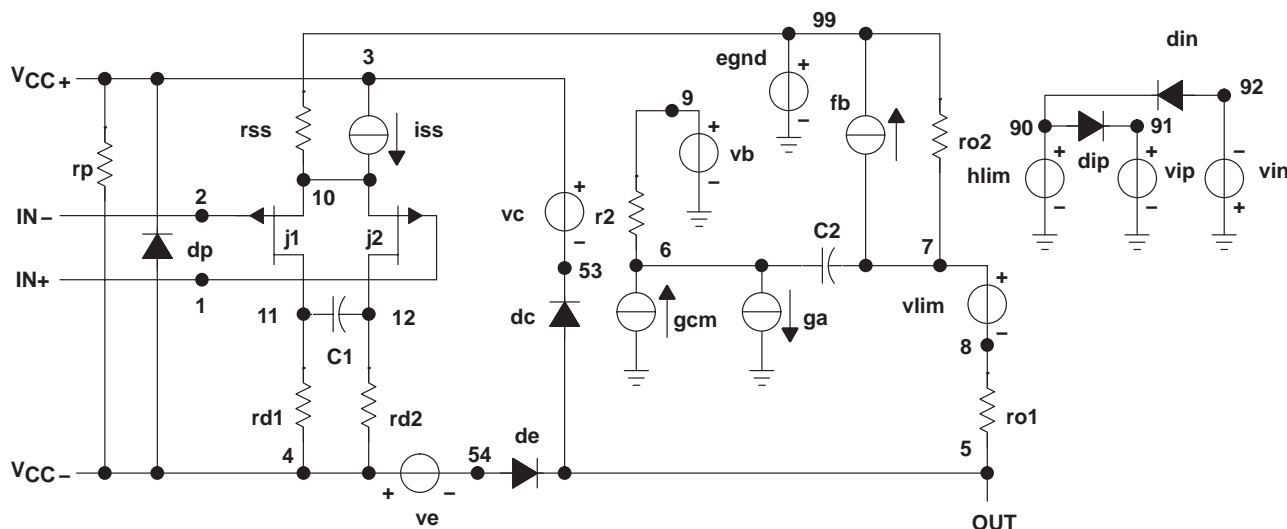
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APPLICATION INFORMATION

macromodel information (continued)



```
.subckt TLC220x 1 2 3 4 5
*
c1 11 12 8.51E-12
c2 6 7 50.00E-12
cpsr 85 86 79.6E-9
dcm+ 81 82 dx
dcm- 83 81 dx
dc 5 53 dx
de 54 5 dx
dlp 90 91 dx
dln 92 90 dx
dp 4 3 dx
ecmr 84 99 (2,99) 1
egnd 99 0 poly(2) (3,0) (4,0) 0 .5 .5
epsr 85 0 poly(1) (3,4) -200E-6 20E-6
ense 89 2 poly(1) (88,0) 100E-6 1
fb 7 99 poly(6) vb vc ve vlp vln
+ vpsr 0 + 895.9E3 -90E3 90E3 90E3 -90E3 895E3
ga 6 0 11 12 314.2E-6
gcm 0 6 10 99 1.295E-9
gpsr 85 86 (85,86) 100E-6
grd1 60 11 (60,11) 3.141E-4
grd2 60 12 (60,12) 3.141E-4
hlim 90 0 vlim 1k
hcmr 80 1 poly(2) vcm+ vcm- 0 1E2 1E2
irp 3 4 965E-6
iss 3 10 dc 135.0E-6
iio 2 0 .5E-12
i1 88 0 1E-21
j1 11 89 10 jx
j2 12 80 10 jx
r2 6 9 100.0E3
rcm 84 81 1k
rn1 88 0 1500
ro1 8 5 188
ro2 7 99 187
rss 10 99 1.481E6
vad 60 4 -.3v
vcm+ 82 99 2.2
vcm- 83 99 -4.5
vb 9 0 dc 0
vc 3 53 dc .9
ve 54 4 dc .8
vlim 7 8 dc 0
vlp 91 0 dc 2.8
vln 0 92 dc 2.8
vpsr 0 86 dc 0
.model dx d(is=800.0E-18)
.model jx pjf(is=500.0E-15 beta=1.462E-3
+ vto=-.155 kf=1E-17)
.endsx
```

Figure 40. Boyle Macromodel and Subcircuit



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9088201M2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088201M2A TLC2201MFKB	Samples
5962-9088201MPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088201MPA TLC2201M	Samples
5962-9088202M2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088202M2A TLC2202MFKB	Samples
5962-9088202MPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088202MPA TLC2202M	Samples
5962-9088203QPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088203QPA TLC2201AM	Samples
5962-9088204Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088204Q2A TLC2202AMFKB	Samples
5962-9088204QPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088204QPA TLC2202AM	Samples
TLC2201ACD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2201AC	Samples
TLC2201ACDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2201AC	Samples
TLC2201AID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2201AI	Samples
TLC2201AIDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2201AI	Samples
TLC2201AMD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2201AM	Samples
TLC2201AMDG4	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2201AM	Samples
TLC2201AMJG	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	TLC2201AMJG	Samples
TLC2201AMJGB	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088203QPA TLC2201AM	Samples
TLC2201CD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2201C	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLC2201CDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2201C	Samples
TLC2201CP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	TLC2201CP	Samples
TLC2201ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2201I	Samples
TLC2201IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2201I	Samples
TLC2201IP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type		TLC2201IP	Samples
TLC2201MFKB	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088201M2A TLC2201MFKB	Samples
TLC2201MJGB	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088201MPA TLC2201M	Samples
TLC2202ACD	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2202AC	Samples
TLC2202ACDR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2202AC	Samples
TLC2202AID	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2202AI	Samples
TLC2202AMFKB	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088204Q2A TLC2202 AMFKB	Samples
TLC2202AMJG	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	TLC2202 AMJG	Samples
TLC2202AMJGB	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088204QPA TLC2202AM	Samples
TLC2202CD	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2202C	Samples
TLC2202CDR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2202C	Samples
TLC2202CP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type		TLC2202CP	Samples
TLC2202CPS	ACTIVE	SO	PS	8	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		P2202	Samples
TLC2202CPSR	ACTIVE	SO	PS	8	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		P2202	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLC2202ID	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		TLC2202I	Samples
TLC2202IP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type		TLC2202IP	Samples
TLC2202MFKB	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9088202M2A TLC2202MFKB	Samples
TLC2202MJG	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	TLC2202MJG	Samples
TLC2202MJGB	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9088202MPA TLC2202M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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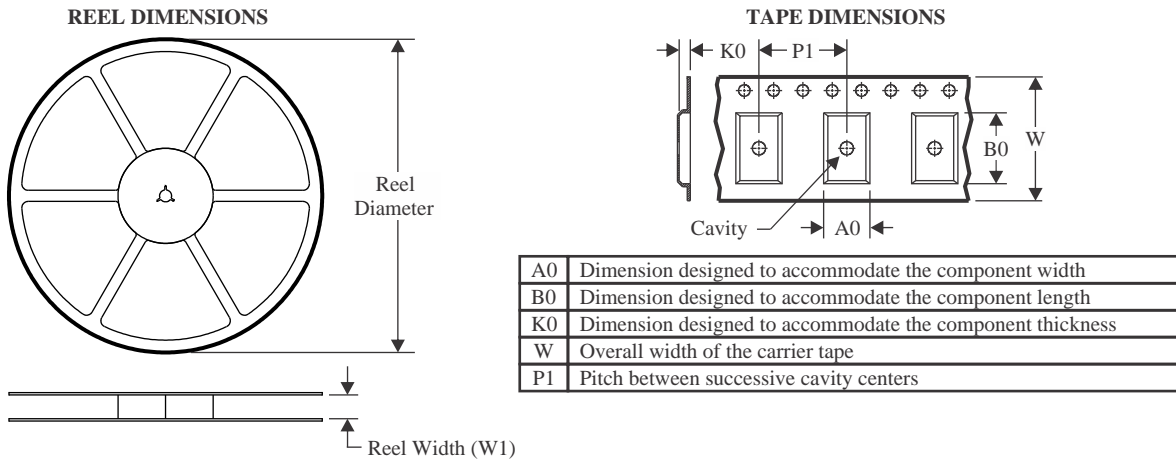
OTHER QUALIFIED VERSIONS OF TLC2201, TLC2201A, TLC2201AM, TLC2201M, TLC2202, TLC2202A, TLC2202AM, TLC2202M :

- Catalog : [TLC2201A](#), [TLC2201](#), [TLC2202A](#), [TLC2202](#)
- Military : [TLC2201M](#), [TLC2201AM](#), [TLC2202M](#), [TLC2202AM](#)
- Space : [TLC2201-SP](#), [TLC2201-SP](#)

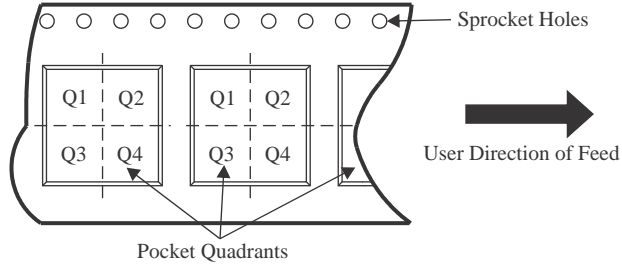
NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications
- Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

TAPE AND REEL INFORMATION



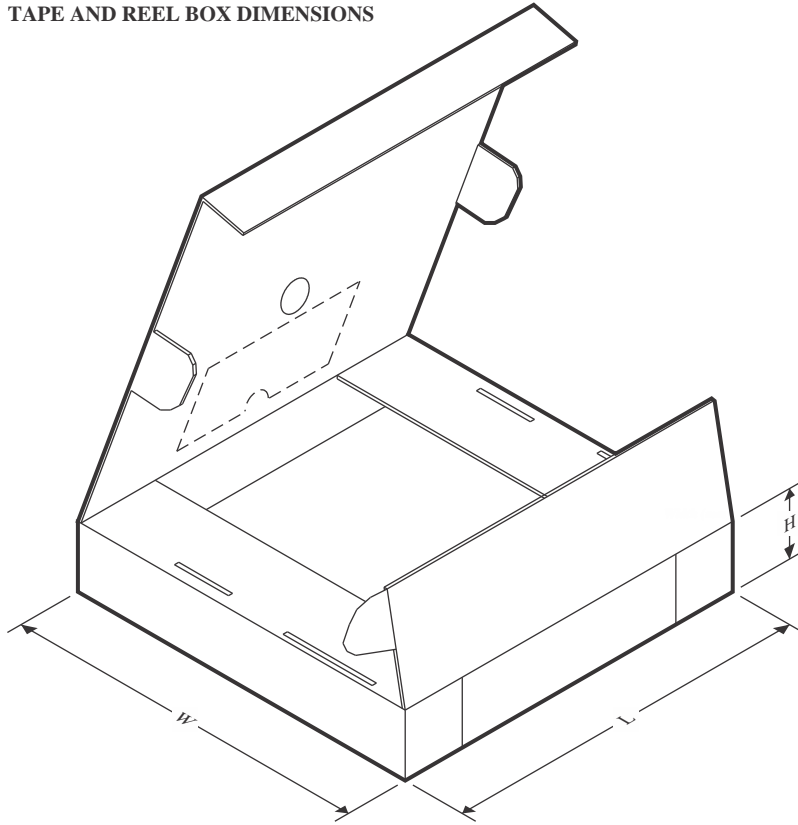
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC2201ACDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2201AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2201CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2201IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2202ACDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC2202CDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC2202CPSR	SO	PS	8	2000	330.0	16.4	8.35	6.6	2.5	12.0	16.0	Q1

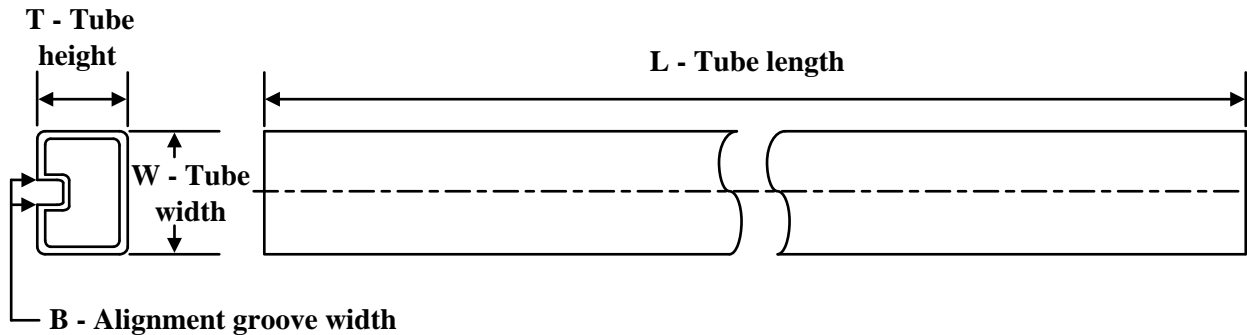
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC2201ACDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC2201AIDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC2201CDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC2201IDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC2202ACDR	SOIC	D	14	2500	350.0	350.0	43.0
TLC2202CDR	SOIC	D	14	2500	350.0	350.0	43.0
TLC2202CPSR	SO	PS	8	2000	356.0	356.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
5962-9088201M2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9088202M2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9088204Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLC2201ACD	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201ACD	D	SOIC	8	75	507	8	3940	4.32
TLC2201AID	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201AID	D	SOIC	8	75	507	8	3940	4.32
TLC2201AMD	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201AMDG4	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201CD	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201CD	D	SOIC	8	75	507	8	3940	4.32
TLC2201CP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2201ID	D	SOIC	8	75	507	8	3940	4.32
TLC2201ID	D	SOIC	8	75	505.46	6.76	3810	4
TLC2201IP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2201MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLC2202ACD	D	SOIC	14	50	505.46	6.76	3810	4
TLC2202AID	D	SOIC	14	50	505.46	6.76	3810	4
TLC2202AMFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLC2202CD	D	SOIC	14	50	505.46	6.76	3810	4
TLC2202CP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2202CPS	PS	SOP	8	80	530	10.5	4000	4.1
TLC2202ID	D	SOIC	14	50	505.46	6.76	3810	4
TLC2202IP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2202MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA

GENERIC PACKAGE VIEW

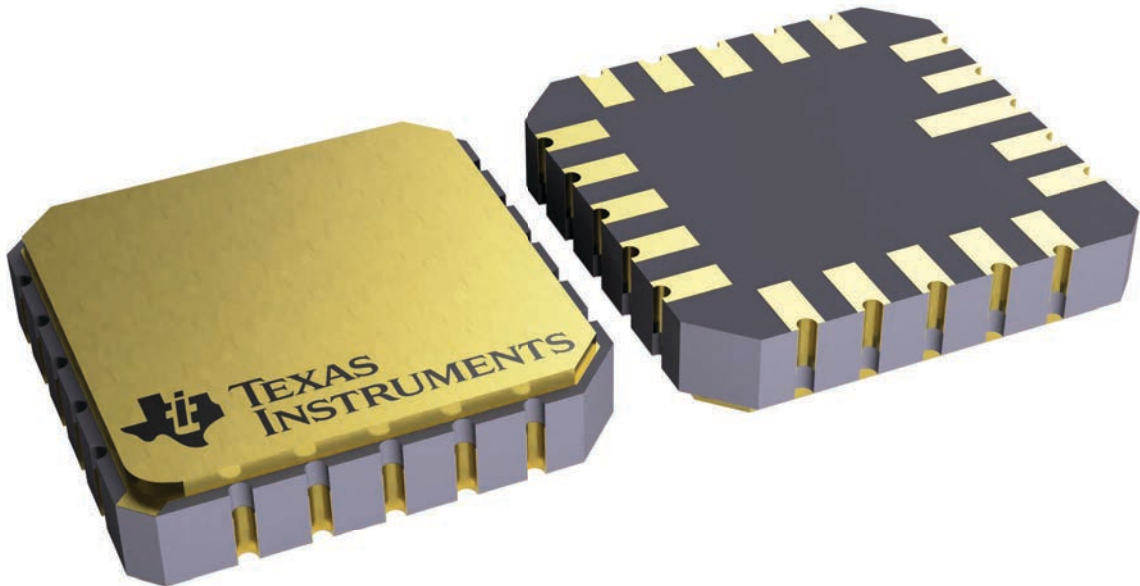
FK 20

LCCC - 2.03 mm max height

8.89 x 8.89, 1.27 mm pitch

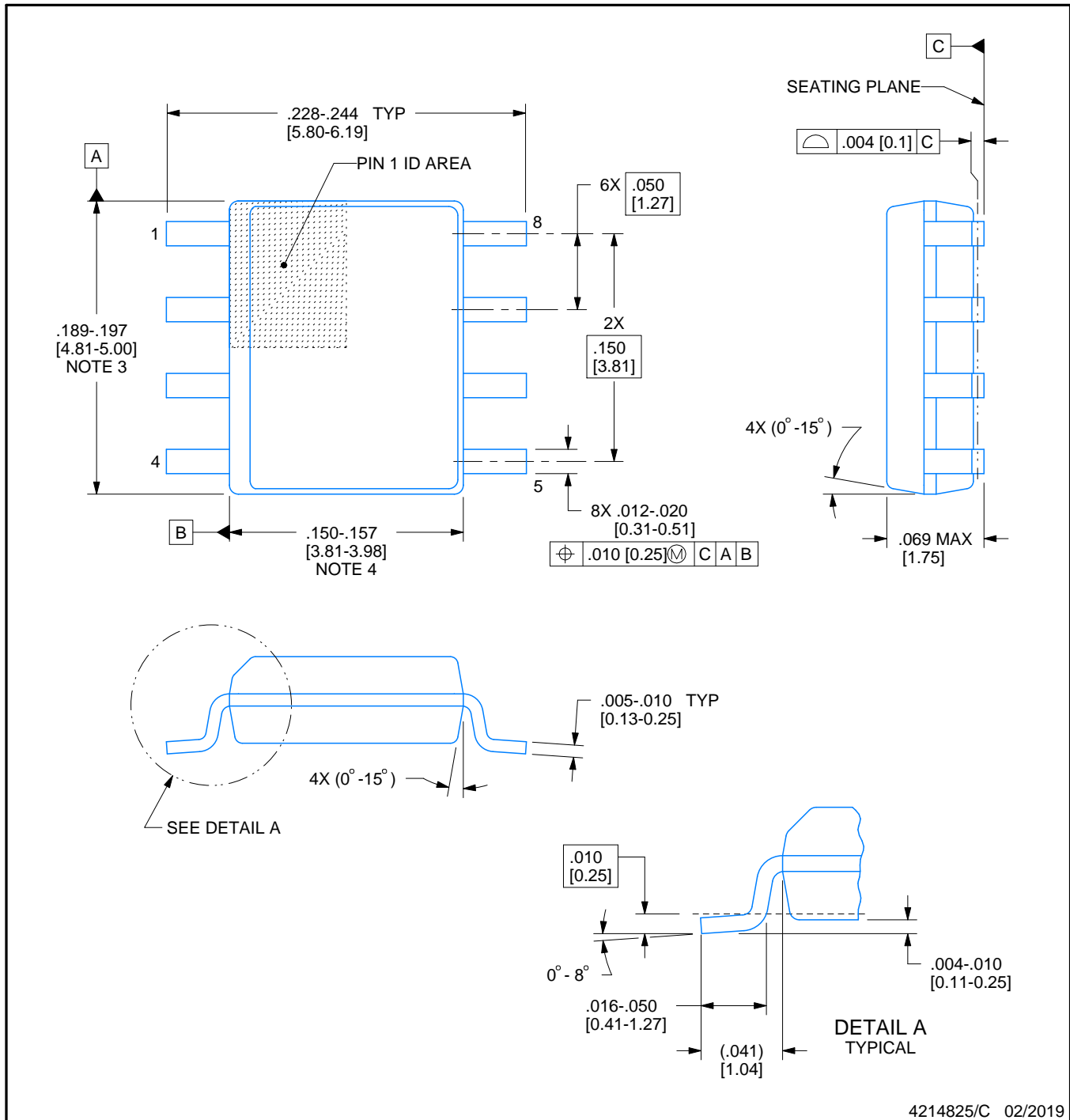
LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



**D0008A****PACKAGE OUTLINE****SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

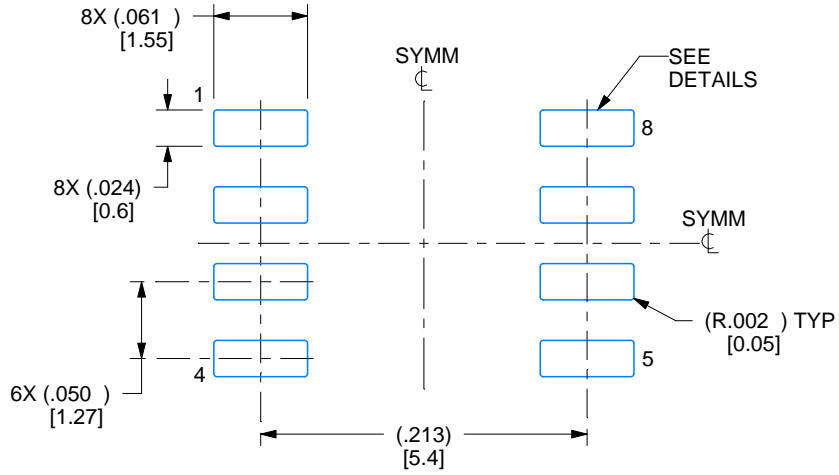
1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed $.006$ [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

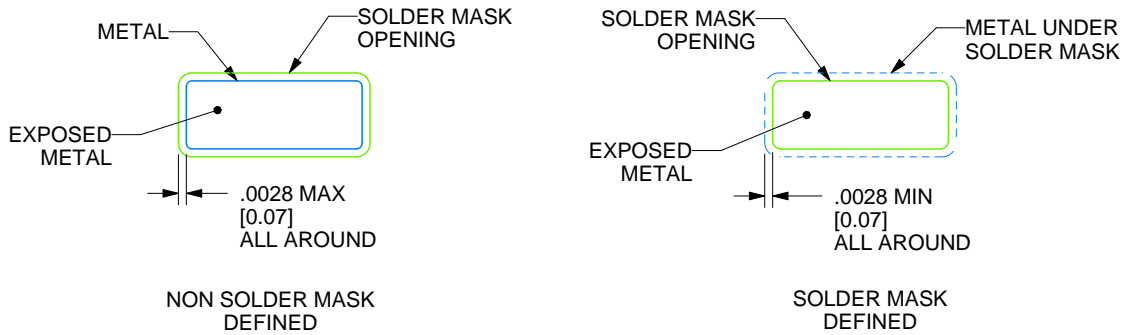
D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
 EXPOSED METAL SHOWN
 SCALE:8X



SOLDER MASK DETAILS

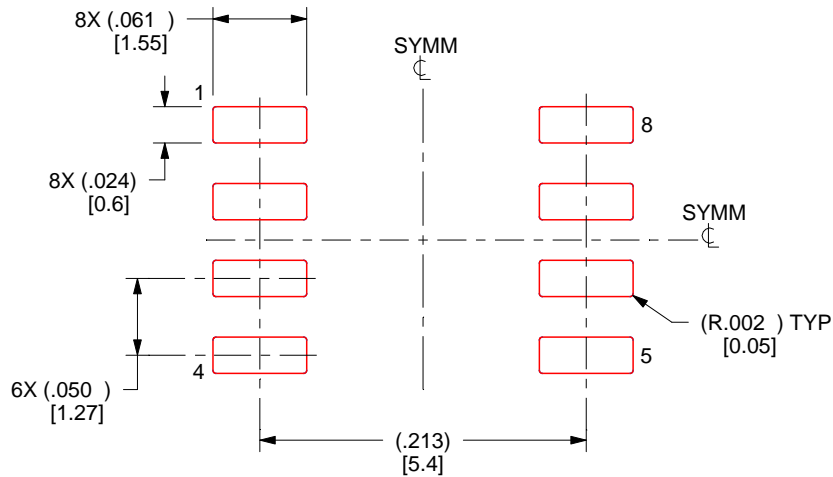
4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN**D0008A****SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
 BASED ON .005 INCH [0.125 MM] THICK STENCIL
 SCALE:8X

4214825/C 02/2019

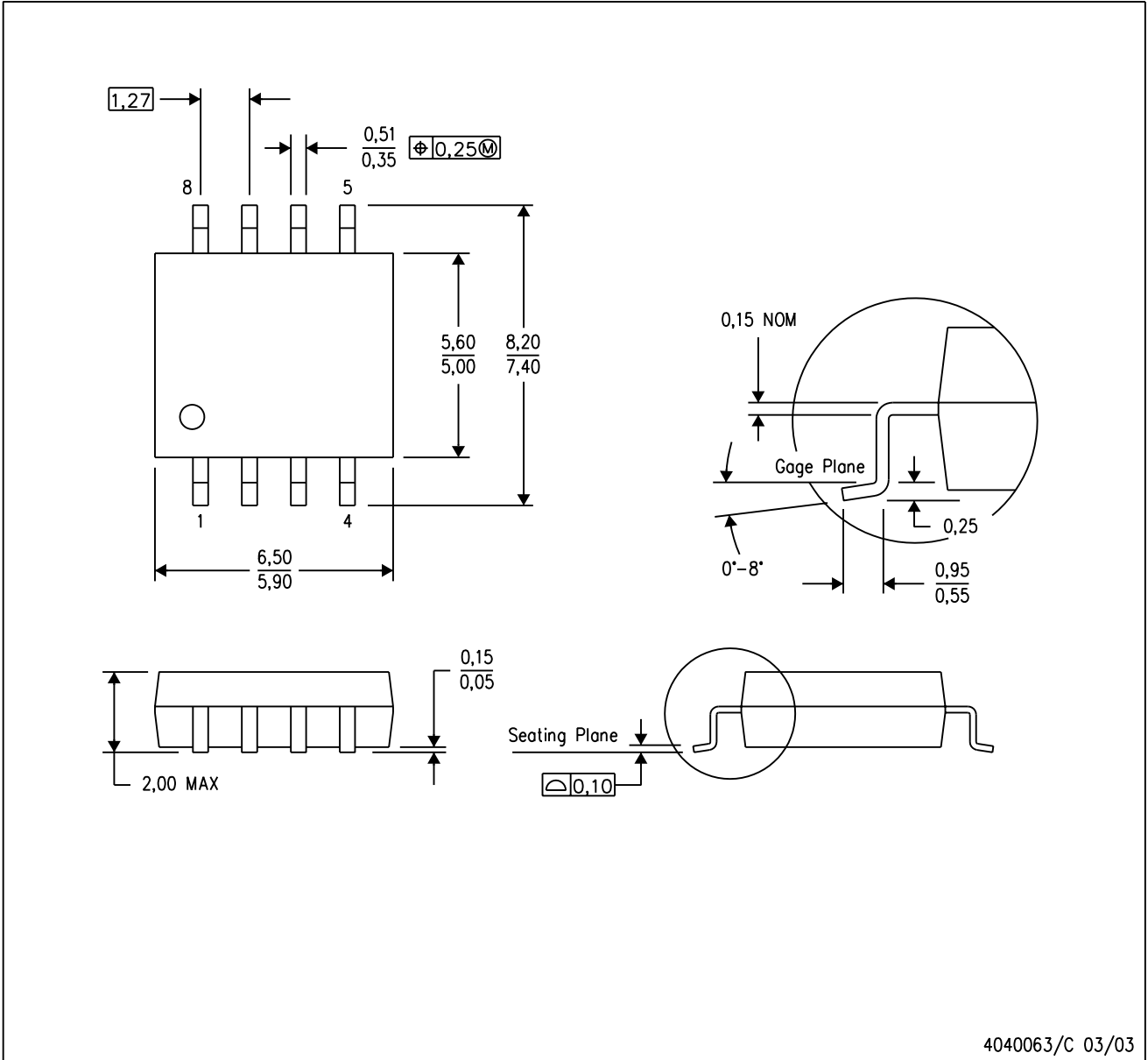
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

MECHANICAL DATA

PS (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

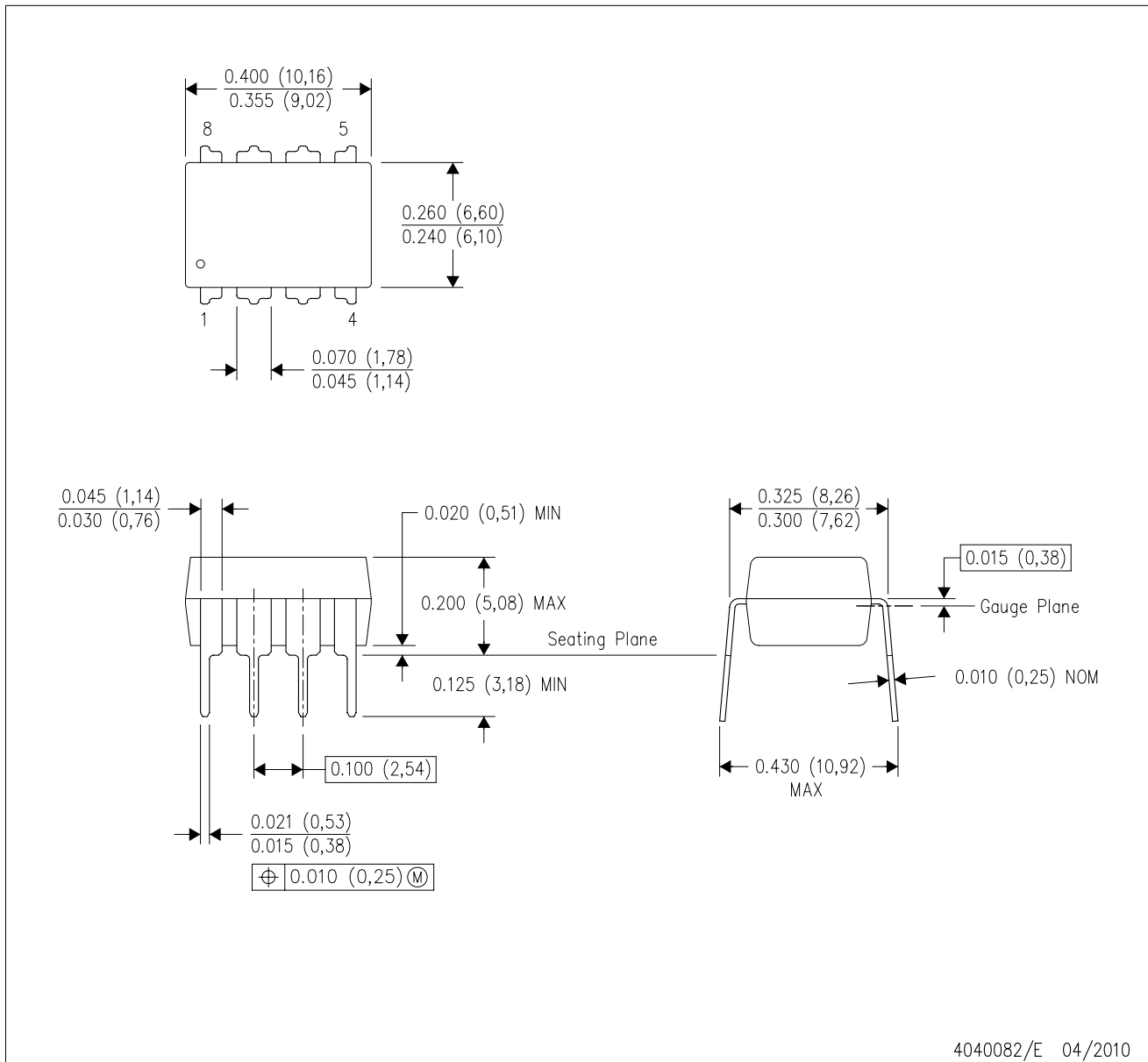


- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

MECHANICAL DATA

P (R-PDIP-T8)

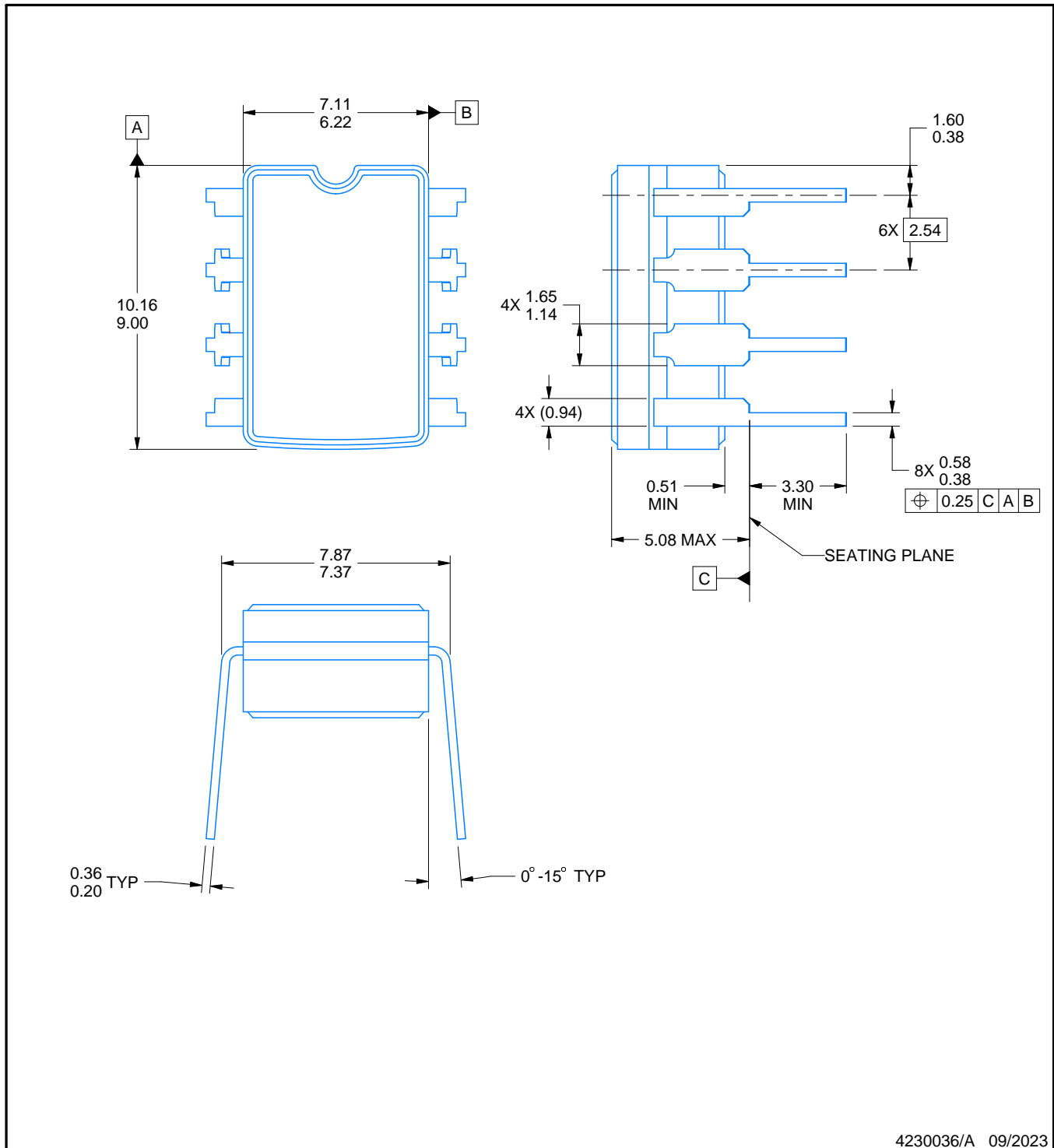
PLASTIC DUAL-IN-LINE PACKAGE



- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - Falls within JEDEC MS-001 variation BA.

PACKAGE OUTLINE**JG0008A****CDIP - 5.08 mm max height**

CERAMIC DUAL IN-LINE PACKAGE

**NOTES:**

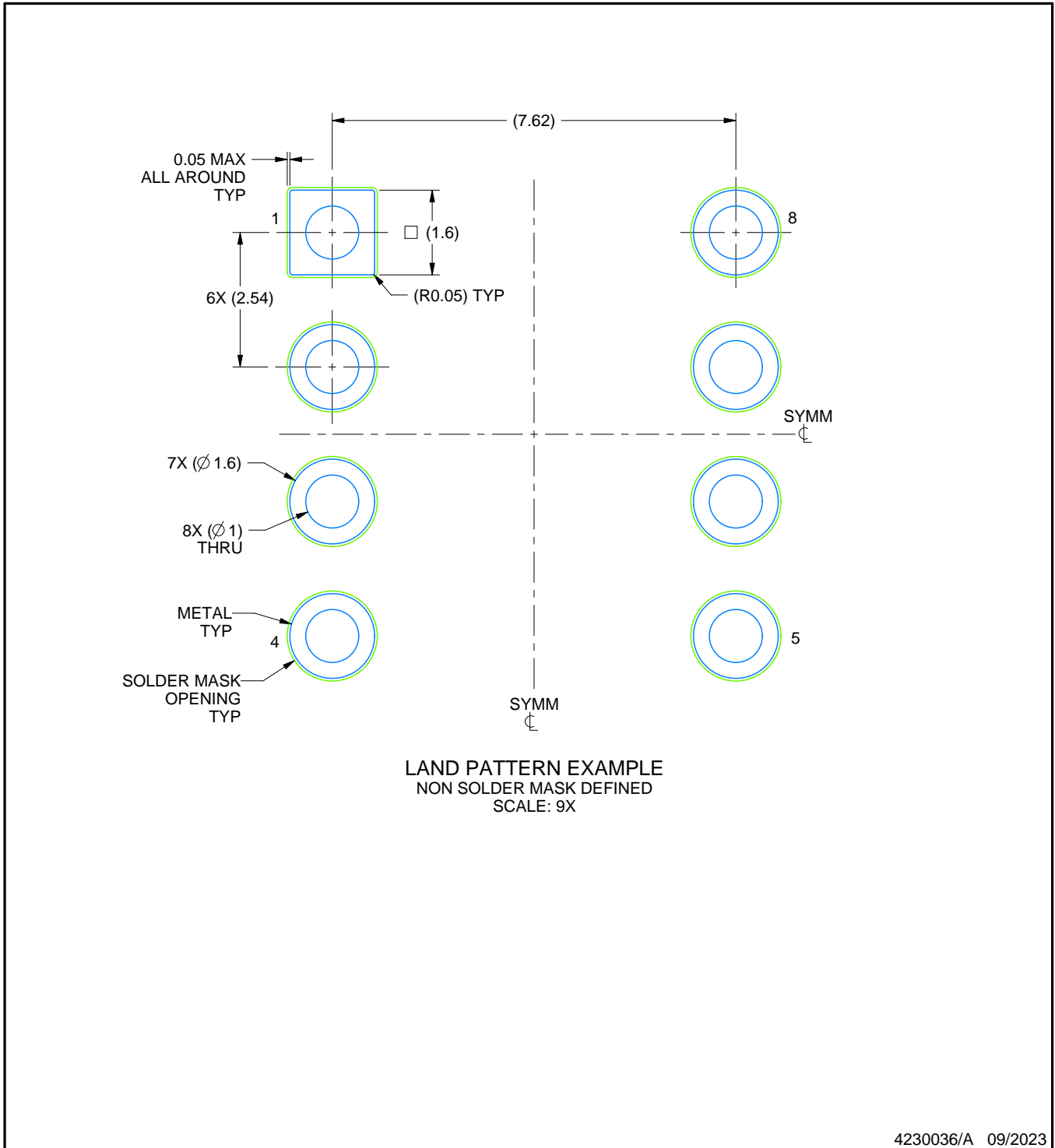
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package can be hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification.
5. Falls within MIL STD 1835 GDIP1-T8

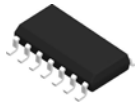
EXAMPLE BOARD LAYOUT

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



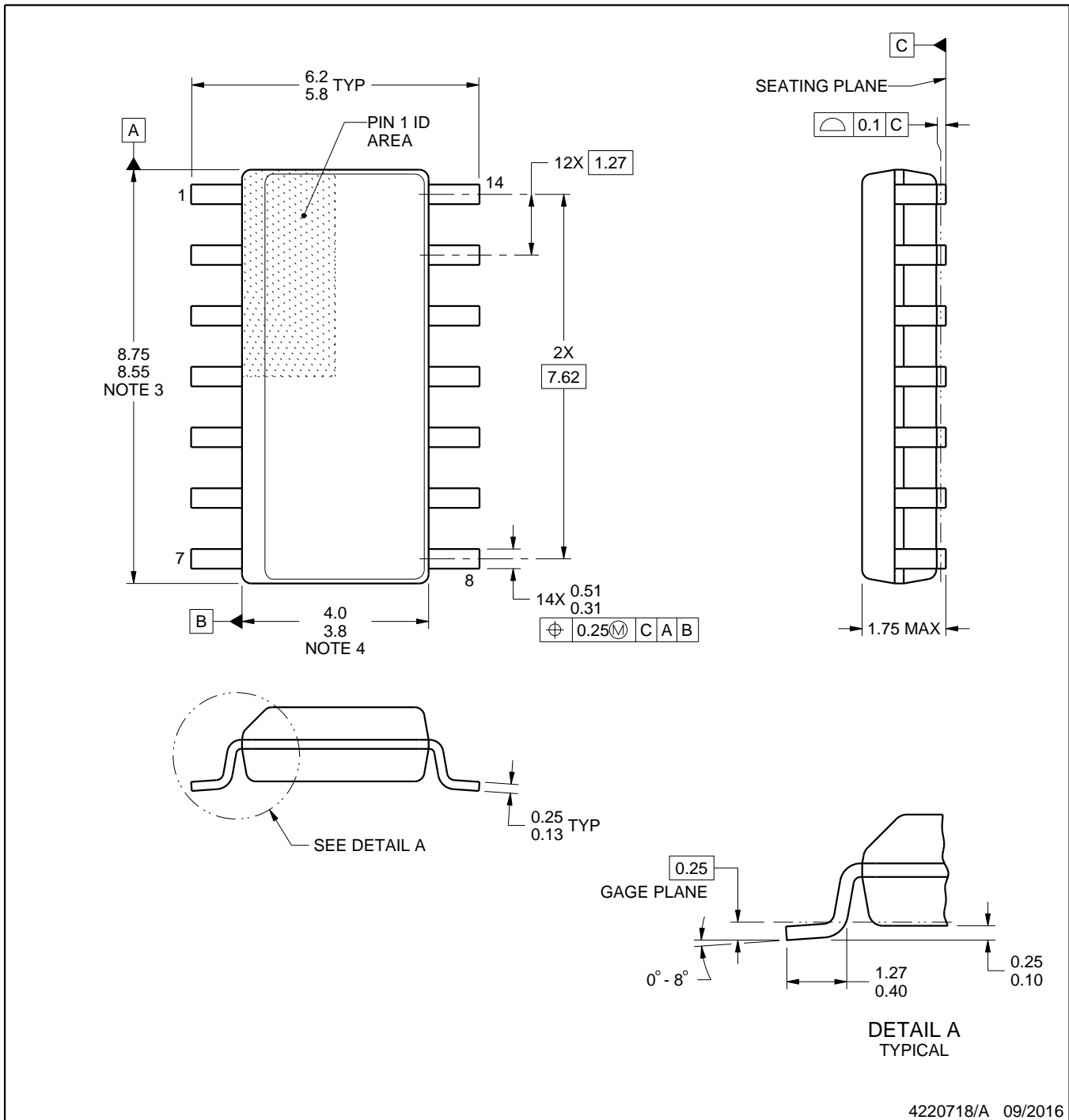


D0014A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

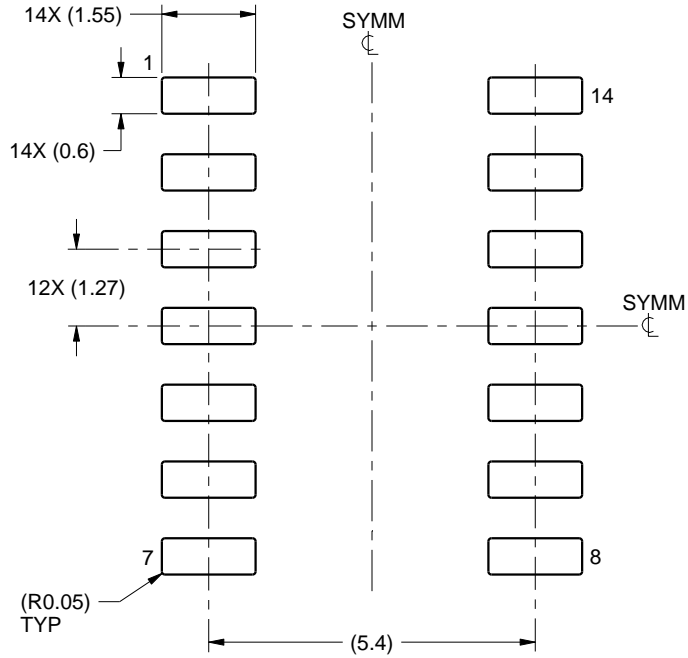
- All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- Reference JEDEC registration MS-012, variation AB.

EXAMPLE BOARD LAYOUT

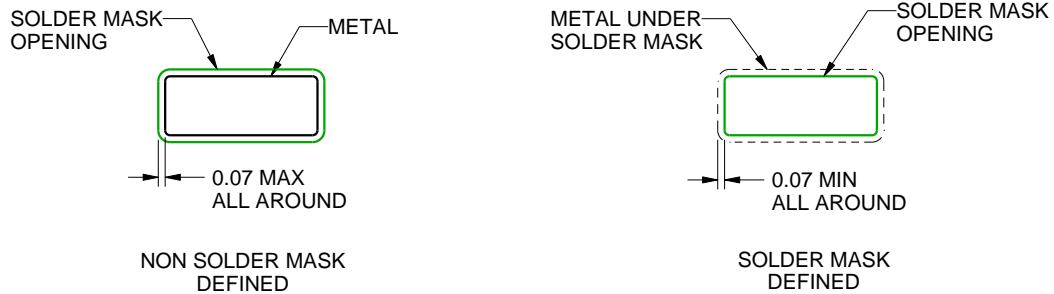
D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

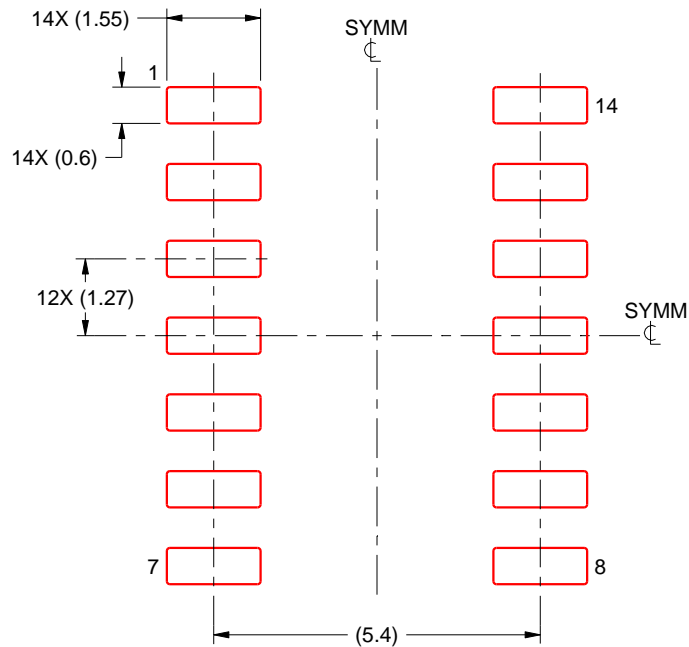
4220718/A 09/2016

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN**D0014A****SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL
 SCALE:8X

4220718/A 09/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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